TEXAS INSTRUMENTS

bq24251, bq24253

ZHCSAF6H −OCTOBER 2012−REVISED AUGUST 2015

具有电源路径管理功能的 bq2425x 2A 单输入 I²C 独立开关模式锂离子电池充电器

1 特性

- 具有独立电源路径的高效开关模式充电器
- 从深度放电电池或者在缺少电池的情况下启动系统
- USB 充电兼容
  - 100mA、500mA、900mA、1.5A 和 2A 可选输入电流限制
- BC1.2 兼容 D+、D− 检测
- 在主机模式下（在 I²C 通信开始之后、看门狗计时器超时之前）
  - 可编程电池充电电压 (V_{BATREG})
  - 可编程充电电流 (I_{CHG})
  - 可编程输入电流限值 (I_{LIM})
  - 基于输入电压的可编程动态电源管理阈值 (V_{IN_DPM})
  - 可编程输入过压保护阈值 (V_{OVP})
  - 可编程安全计时器
- 针对以下各项的电阻器可编程默认值：
  - 具有电流监控输出的高达 2A 的 I_{CHG} (ISET)
  - 具有电流监控输出的高达 2A 的 I_{LIM} (ILIM)
  - V_{IN_DPM} (VDPM)
- 看门狗计时器禁用位
- 集成 4.9V、50mA LDO
- 完整的系统级保护
  - 输入 UVLO、输入过压保护 (OVP)、电池 OVP、睡眠模式、VIN_DPM
  - 输入电流限制
  - 充电电流限制
  - 热调节
  - 热关断
  - 符合 JEITA 标准的基于电压的 NTC 监控输入
  - 安全计时器
- 22V 绝对最大输入电压额定值
- 10.5V 最大运行输入电压
- 用于实现高达 2A 的充电速度的低 $R_{DS(on)}$ 集成功率 FET
- 开漏状态输出

- 可支持小型电感器的运行频率为 3MHz 的同步固定频率 PWM 控制器
- AnyBoot 可靠电池检测算法
- 用于在任一给定充电电流上缩短充电时间的充电时间优化器
- 2.40mm x 2.00mm 30 焊球 DSBGA 和 4mm x 4mm 24 引脚 QFN 封装
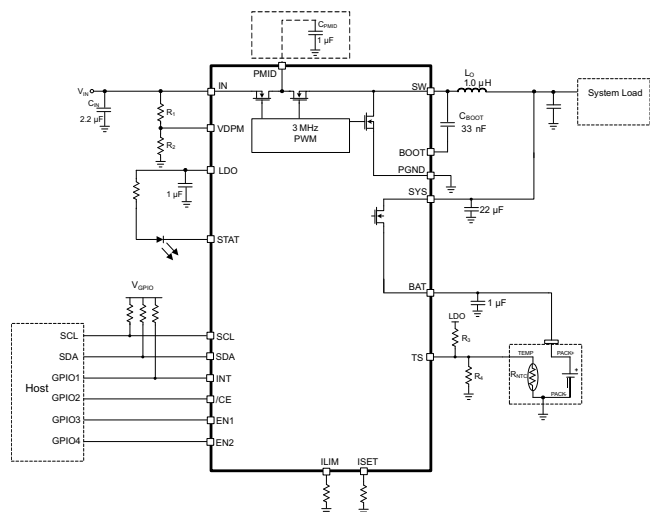
2 应用

- 手机和智能手机
- MP3 播放器
- 便携式媒体播放器
- 手持设备

3 说明

bq24251 和 bq24253 是高度集成的单节锂离子电池充电器和系统电源路径管理器件，适用于采用高容量电池的空间受限型便携式 应用 。单节电池充电器具有一个由 USB 端口或交流壁式适配器供电的单一输入，用于提供多用途解决方案。

器件信息(1)

器件型号	封装	封装尺寸（标称值）
bq24251 bq24253	VQFN (24)	4.00mm x 4.00mm
	DSBGA (30)	2.40mm x 2.00mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。

English Data Sheet: SLUSBA1

目录

4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

Changes from Revision G (January 2015) to Revision H   Page

- 已更改 将 20V 最大输入电压额定值特性项目更改成了 22V，以匹配"绝对最大额定值"表 1
- 已删除 在整个产品说明书中删除了 bq24250 器件 1
- Changed Figure 11 and Figure 12 image X-axis labels from "Temperature (fC)" to "Temperature (°C)" 15

Changes from Revision F (December 2014) to Revision G   Page

- Deleted Lead temperature (soldering) spec from Absolute Maximum Ratings table. See Package Option Addendum. 8
- Changed table heading from Handling Ratings to ESD Ratings. Moved T_{stg} spec to the Absolute Maximum Ratings table 8
- Changed the test condition of IBAT- Battery discharge current in SYSOFF mode: Removed "(BAT, SW, SYS)" 9
- Added spec for I_{IN}/I_{ILIM} ratio 11

Changes from Revision E (December 2013) to Revision F   Page

- 已添加 处理额定值表，特性 说明 部分、器件功能模式、应用和实施 部分、电源相关建议 部分、布局 部分、器件和
  文档支持 部分以及机械、封装和可订购信息 部分 1
- Deleted the minimum spec for RILIM-SHORT and changed the typical value to 55 ohm and maximum spec to 75 ohm. 11
- Changed V_{LDO} values to (4.65, 4.85, 5.04) and added description in the second column 12

Changes from Revision D (July 2013) to Revision E   Page

- Changed VDPM pin desctiption from "......sets a default of 4.36V" to ".......sets a default of 4.68V" 6
- Changed text string in the V_{IN_DLM} settings description from: "The ISET resistor must be floated in order to avoid an internal fault." to: "The ISET resistor must be connected in order to avoid an unstable charging state." 20
- Changed text string in the Sleep Mode description from: "...sends a single 256µs pulse is sent on the STAT and INT outputs..." to: "...sends a single 256µs pulse on the STAT and INT outputs..." 26
- Changed text string in the Input Over-Voltage Protection description from: "...turns the battery FET, sends a single

Changes from Revision C (June 2013) to Revision D   Page

Changes from Revision B (May 2013) to Revision C   Page

Changes from Revision A (March 2013) to Revision B   Page

Changes from Original (October 2012) to Revision A   Page

5 说明 （续）

电源路径管理功能使得 bq24251 和 bq24253 能够在对电池进行独立充电的同时通过一个高效的直流/直流转换器为系统供电。此充电器一直监视电池电流并在系统负载所需电流高于输入电流限值时减小充电电流。该减小的充电电流可实现正常的充电终止并且使得系统能够在电池组有缺陷或不存在电池组的情况下运行。此外，该减小的充电电流使得即使在电池已完全放电或没有电池的情况下也能够瞬时启动系统。当适配器无法提供峰值系统电流时，此电源路径管理架构还允许电池补充系统电流要求。该电流要求补充支持使用较小的适配器。

电池充电分为四个阶段：涓流充电、预充电、恒定电流和恒定电压。在所有充电阶段，一个内部控制环路监视 IC 结温并且在超过内部温度阈值时减小充电电流。此外，还包括一个基于电压且符合 JEITA 标准的电池组热敏电阻器监控输入 (TS)，用于监控电池温度，以实现安全充电。

6 Device Options

DEVICE	DEFAULT OVP	D+/D- OR EN1/EN2	INT OR PG	DEFAULT V_{OREG}	MINSYS	TS PROFILE	I²C OR STAND ALONE	I²C ADDRESS
bq24251	10.5 V	D+/D-	$\overline{PG}$	4.2 V	3.5V	JEITA	I²C + SA	0x6A
bq24253	10.5 V	D+/D- and EN1/EN2	$\overline{PG}$	4.2 V	3.5 V	JEITA	SA Only	N/A

7 Pin Configuration and Functions

YFF Package / RGE Package
30-Pin DSBGA / 24-Pin QFN
Top View / Top View

bq24251 DSBGA

bq24253 DSBGA

Pin Functions

NAME	PIN bq24251 YFF	PIN bq24251 RGE	PIN bq24253 YFF	PIN bq24253 RGE	I/O	DESCRIPTION
IN	A5,B5,C5	19	A5,B5,C5	19	I	Input power supply. IN is connected to the external DC supply (AC adapter or USB port). Bypass IN to PGND with >2µF ceramic capacitor
PMID	D5	20	D5	20	I	Connection between blocking FET and high-side FET.
SW	A4, B4, C4	17–18	A4, B4, C4	17–18	O	Inductor Connection. Connect to the switching side of the external inductor.
BOOT	E5	21	E5	21	I	High Side MOSFET Gate Driver Supply. Connect a 0.033µF ceramic capacitor (voltage rating > 15V) from BOOT to SW to supply the gate drive for the high side MOSFETs.
PGND	A3, B3, C3, F3	15–16	A3, B3, C3, F3	15–16		Ground terminal. Connect to the ground plane of the circuit.
SYS	A2, B2, C2	13–14	A2, B2, C2	13–14	I	System Voltage Sense and switched-mode power supply (SMPS) output filter connection. Connect SYS to the system output at the output bulk capacitors. Bypass SYS locally with >20µF.
BAT	A1, B1, C1	11–12	A1, B1, C1	11–12	I/O	Battery Connection. Connect to the positive terminal of the battery. Additionally, bypass BAT with a >1µF capacitor.
TS	F1	9	F1	9	I	Battery Pack NTC Monitor. Connect TS to the center tap of a resistor divider from LDO to GND. The NTC is connected from TS to GND. The TS function provides 4 thresholds for JEITA or PSE compatibility. See the *NTC Monitor* section for more details on operation and selecting the resistor values.
VDPM	E4	23	E4	23	I	Input DPM Programming Input. Connect a resistor divider between IN and GND with VDPM connected to the center tap to program the Input Voltage based Dynamic Power Management threshold (V_{IN_DPM}). The input current is reduced to maintain the supply voltage at V_{IN_DPM}. The reference for the regulator is 1.2V. Short pin to GND if external resistors are not desired—this sets a default of 4.68V for the input DPM threshold.
ISET	D1	10	D1	10	I	Charge Current Programming Input. Connect a resistor from ISET to GND to program the fast charge current. The charge current is programmable from 300mA to 2A.
ILIM	F5	22	F5	22	I	Input Current Limit Programming Input. Connect a resistor from ILIM to GND to program the input current limit for IN. The current limit is programmable from 0.5A to 2A. ILIM has no effect on the USB input. If an external resistor is not desired, short to GND for a 2A default setting.
$\overline{CE}$	D4	1	D4	1	I	Charge Enable Active-Low Input. Connect CE to a high logic level to place the battery charger in standby mode.
EN1	–	–	F2	5	I	Input Current Limit Configuration Inputs. Use EN1, and EN2 to control the maximum input current and enable USB compliance. See Table 1 for programming details.
EN2	–	–	E2	6	I	
$\overline{CHG}$	–	–	E3	7	O	Charge Status Open Drain Output. $\overline{CHG}$ is pulled low when a charge cycle starts and remains low while charging. $\overline{CHG}$ is high impedance when the charging terminates and when no supply exists. $\overline{CHG}$ does not indicate recharge cycles.
$\overline{PG}$	E1	8	E1	8	O	Power Good Open Drain Output. $\overline{PG}$ is pulled low when a valid supply is connected to IN. A valid supply is between $V_{BAT}+V_{SLP}$ and V_{OVP}. If no supply is connected or the supply is out of this range, $\overline{PG}$ is high impedance.

Pin Functions (continued)

NAME	bq24251		bq24253		I/O	DESCRIPTION
	YFF	RGE	YFF	RGE		
STAT	E3	7	–	–	O	Status Output. STAT is an open-drain output that signals charging status and fault interrupts. STAT pulls low during charging. STAT is high impedance when charging is complete or the charger is disabled. When a fault occurs, a 256µs pulse is sent out as an interrupt for the host. STAT is enabled/disabled using the EN_STAT bit in the control register. STAT will indicate recharge cycles. Connect STAT to a logic rail using an LED for visual indication or through a 10kΩ resistor to communicate with the host processor.
INT	–	–	–	–	O	Status Output. INT is an open-drain output that signals charging status and fault interrupts. INT pulls low during charging. INT is high impedance when charging is complete or the charger is disabled. When a fault occurs, a 256µs pulse is sent out as an interrupt for the host. INT will indicate recharge cycles. Connect INT to a logic rail through a 10kΩ resistor to communicate with the host processor.
SCL	E2	6	–	–	I	I²C Interface Clock. Connect SCL to the logic rail through a 10kΩ resistor.
SDA	F2	5	–	–	I/O	I²C Interface Data. Connect SDA to the logic rail through a 10kΩ resistor.
D+	D3	2	D3	2	I	BC1.2 compatible D+/D– Based Adapter Detection. Detects DCP, SDP, and CDP. Also complies with the unconnected dead battery provision clause. D+ and D- are connected to the D+ and D– outputs of the USB port at power up. Also includes the detection of Apple™ and TomTom™ adapters where a 500mA input current limit is enabled. The $\overline{PG}$ pin will remain high impedance until the detection has completed.
D–	D2	3	D2	3	I	
LDO	F4	24	F4	24	O	LDO output. LDO is regulated to 4.9V and drives up to 50mA. Bypass LDO with a 1µF ceramic Capacitor. LDO is enabled when $V_{UVLO} < V_{IN} <18V$.
AGND	–	4	–	4		Analog Ground for QFN only. Connect to the thermal pad and the ground plane of the circuit.

8 Specifications

8.1 Absolute Maximum Ratings[1]

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
Pin Voltage Range (with respect to GND)	IN	−0.3	22	V
	SW	−0.7	12	V
	BOOT	−0.3	20	V
	LDO,STAT, INT, /CHG, /PG, EN1, EN2, EN3, /CE, D+, D-, ILIM, ISET, VDPM, TS, SCL, SDA	−0.3	7	V
	SYS, BAT	−0.3	5	V
BOOT relative to SW		−0.3	7	V
Output Current (Continuous)	IN		2	A
	SYS, BAT		4	
Output Sink Current	STAT, /CHG, /PG		5	mA
Operating free-air temperature range		−40	85	°C
Junction temperature, T_J		−40	125	°C
Input Power	IN		15	W
Storage temperature, T_{stg}		−65	150	°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

8.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins[1]	±2000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins[2]	±500	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

8.3 Recommended Operating Conditions

All voltages are with respect to PGND if not specified. Currents are positive into, negative out of the specified terminal.
Consult Packaging Section of the data book for thermal limitations and considerations of packages

		MIN	MAX	UNIT
V_{IN}	IN voltage range	4.35	18[1]	V
	IN operating voltage range	4.35	10.5	
I_{IN}	Input current		2	A
I_{CHG}	Current in charge mode, BAT		2	A
I_{DISCHG}	Current in discharge mode, BAT		4	A
R_{ISET}	Charge current programming resistor range	75		Ω
R_{ILIM}	Input current limit programming resistor range	105		Ω
P_{IN}	Input Power		12	W
T_J	Operating junction temperature range	0	125	°C

(1) The inherent switching noise voltage spikes should not exceed the absolute maximum rating on either the BOOT or SW pins. Small routing loops for the power nets in layout minimize switching noise.

8.4 Thermal Information

THERMAL METRIC[1]		YFF (30 PINS)	RGE (24 PINS)	UNIT
$R_{\theta JA}$	Junction-to-ambient thermal resistance	76.5	32.9	°C/W
$R_{\theta JCtop}$	Junction-to-case (top) thermal resistance	0.2	32.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	44	10.6	°C/W
ψ_{JT}	Junction-to-top characterization parameter	1.6	0.3	°C/W
ψ_{JB}	Junction-to-board characterization parameter	43.4	10.7	°C/W
$R_{\theta JCbot}$	Junction-to-case (bottom) thermal resistance	N/A	2.3	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, SPRA953.

8.5 Electrical Characteristics

$V_{UVLO} < V_{IN} < V_{OVP}$ and $V_{IN} > V_{BAT}+V_{SLP}$, T_J = 0ºC-125°C and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
INPUT CURRENTS						
I_{IN}	Supply current from IN	$V_{DPM} < V_{IN} < V_{OVP}$ AND $V_{IN} > V_{BAT}+V_{SLP}$ PWM switching, CE Enable		13		mA
		$V_{DPM} < V_{IN} < V_{OVP}$ AND $V_{IN} > V_{BAT}+V_{SLP}$ PWM switching, CE Disable			5	
		V_{IN}= 5.5V, 0°C< T_J < 85°C, High-Z Mode		170	225	µA
I_{BAT}	Battery discharge current in high impedance mode, (BAT, SW, SYS)	0°C< T_J < 85°C, VBAT = 4.2 V, VIN = 0V or 5V, High-Z Mode		16	22	µA
	Battery discharge current in SYSOFF mode	0°C< T_J < 85°C, VBAT = 4.2 V, VIN < UVLO, SYSOFF Mode			1	
POWER-PATH MANAGEMENT						
V_{SYSREG}	System Regulation Voltage	MINSYS stage (no DPM or DPPM)	–1%	3.52	1%	V
		MINSYS stage (DPM or DPPM active)	–1.50%	V_{MINSYS} –200mV	1.50%	
		BATREG stage		V_{BAT} + I_{CHG} R_{on}		
		SYSREG stage	V_{BATREG} +2.1%	V_{BATREG} +3.1%	V_{BATREG} +4.1%	
V_{SPLM}	Enter supplement mode voltage threshold	V_{BAT} = 3.6V		V_{BAT} – 40mV		V
I_{SPLM}	Exit supplement mode current threshold	V_{BAT} = 3.6V		20		mA
$t_{DGL(SC1)}$	Deglitch Time, OUT Short Circuit during Discharge or Supplement Mode	Measured from (V_{BAT} – V_{SYS}) = 300 mV		740		µs
$t_{REC(SC1)}$	Recovery Time, OUT Short Circuit during Discharge or Supplement Mode			64		ms
BATTERY CHARGER						
$R_{ON(BAT-SYS)}$	Internal battery charger MOSFET on-resistance	Measured from BAT to SYS, V_{BAT} = 4.2V (WCSP)		20	30	mΩ
		Measured from BAT to SYS, V_{BAT} = 4.2V (QFN)		30	40	

Electrical Characteristics (continued)

$V_{UVLO} < V_{IN} < V_{OVP}$ and $V_{IN} > V_{BAT}+V_{SLP}$, T_J = 0ºC-125°C and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{BATREG}	I²C host mode	Operating in voltage regulation, Programmable Range	3.5		4.44	V
	SA mode or I²C default mode			4.2		
	Voltage Regulation Accuracy	T_J = 25°C	−0.5%		0.5%	
		T_J = 0°C to 125°C	−0.75%		0.75%	
I_{CHG}	Fast Charge Current Range	$V_{LOWV} \le V_{BAT} < V_{BAT(REG)}$	500		2000	mA
	Fast Charge Current Accuracy	I²C mode	−7%		7%	
$I_{CHG-LOW}$	Low Charge Current Setting	Set via I²C	297	330	363	mA
K_{ISET}	Programmable Fast Charge Current Factor	$I_{CHG} = \dfrac{K_{ISET}}{R_{ISET}}$	232.5	250	267.5	AΩ
V_{ISET}	Maximum ISET pin voltage (in regulation)			0.42		V
$R_{ISET-SHORT}$	Short circuit resistance threshold		45	55	75	Ω
V_{LOWV}	Pre-charge to fast charge threshold	Rising	2.9	3	3.1	V
	Hysteresis for V_{LOWV}	Battery voltage falling		100		mV
I_{PRECHG}	Pr-charge current ($V_{BATUVLO} < V_{BAT} < V_{LOWV}$)	Ipre-chg is a precentile of the external fast charge settings.	8	10	12	%
$t_{DGL(LOWV)}$	Deglitch time for pre-charge to fast charge transition			32		ms
V_{BAT_UVLO}	Battery Under voltage lockout threshold	V_{BAT} rising	2.37	2.5	2.63	V
	Battery UVLO hysteresis			200		mV
$V_{BATSHRT}$	Trickle charge to pre-charge threshold		1.9	2	2.1	V
	Hysteresis for VBATSHRT	Battery voltage falling		100		mV
$I_{BATSHRT}$	Trickle charge mode charge current ($V_{BAT} < V_{BATSHRT}$)		25	35	50	mA
$t_{DGL(BATSHRT)}$	Deglitch time for trickle charge to pre-charge transition			256		us
I_{TERM}	Termination Current Threshold	Termination current on SA only		10		%ICHG
	Termination Current Threshold Tolerance		−10%		10%	
$t_{DGL(TERM)}$	Deglitch time for charge termination	Both rising and falling, 2-mV over-drive, t_{RISE}, t_{FALL} = 100 ns		64		ms
V_{RCH}	Recharge threshold voltage	Below V_{BATREG}	70	115	160	mV
$t_{DGL(RCH)}$	Deglitch time	V_{BAT} falling below V_{RCH}, t_{FALL} = 100 ns		32		ms
BATTERY DETECTION						
V_{BATREG_HI}	Battery Detection High Regulation Voltage	Same as V_{BATREG}		V_{BATREG}		V
V_{BATREG_LO}	Battery Detection Low Regulation Voltage	360 mV offset from V_{BATREG}		V_{BATREG} −480mV		V
$V_{BATDET\ Hi}$	Battery detection comparator	V_{BATREG} = VBATREG_HI		V_{BATREG} −120mV		V
$V_{BATDET\ LO}$	Battery detection comparator	V_{BATREG} = V_{BATREG_LO}		V_{BATREG} +120mV		V
I_{DETECT}	Battery Detection Current Sink	Always on during battery detection		7.5		mA
t_{DETECT}	Battery detection time	For both V_{BATREG_HI} and V_{BATREG_LO}		32		ms
Tsafe	Safety Timer Accuracy		−10%		+10%	

Electrical Characteristics (continued)

$V_{UVLO} < V_{IN} < V_{OVP}$ and $V_{IN} > V_{BAT}+V_{SLP}$, T_J = 0ºC-125°C and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
INPUT PROTECTION						
I_{IN}	Input current limiting	I_{IN_LIMIT} = 100 mA	90	95	100	mA
		I_{IN_LIMIT} = 150 mA	135	142.5	150	
		I_{IN_LIMIT} = 500 mA	450	475	500	
		I_{IN_LIMIT} = 900 mA	810	860	910	
		I_{IN_LIMIT} = 1500 mA	1400	1475	1550	
		I_{IN_LIMIT} = 2000 mA	1850	1950	2050	
		I_{IN_LIMIT} = External	$I_{LIM} = \dfrac{K_{ILIM}}{R_{ILIM}}$			
I_{LIM}	Maximum input current limit programmable range for IN input		500		2000	mA
K_{ILIM}	Maximum input current factor for IN input	I_{LIM} = 500 mA to 2.0 A	240	270	300	AΩ
V_{ILIM}	Maximum ILIM pin voltage (in regulation)			0.42		V
I_{IN} /I_{ILIM}	Ratio between input current and the ILIM pin current in external control or stand alone mode	External ILIM control or stand alone		540		A/A
$R_{ILIM\text{-}SHORT}$	Short circuit resistance threshold			55	75	Ω
V_{IN_DPM}	V_{IN_DPM} threshold range	SA mode	4.2		10	V
		I²C mode	4.2		4.76	
	V_{IN_DPM} threshold for USB Input in SA mode	USB100, USB150, USB500, USB900, current limit selected. Also I²C register default.	4.27	4.36	4.45	
	V_{IN_DPM} threshold with adaptor current limit and VDPM shorted to GND	Must set to external resistor settings via the EN1/EN2 pins or the I²C register interface.	V_{IN_DPM} −2%	V_{IN_DPM}	V_{IN_DPM} +2%	
	V_{IN_DPM} threshold Accuracy	Both I²C and SA mode	−2%		2%	
V_{REF_DPM}	DPM regulation voltage	External resistor setting only	1.15	1.2	1.25	V
V_{DPM_SHRT}	VIN_DPM short threshold	If VDPM is shorted to ground, V_{IN_DPM} threshold will use internal default value		0.3		V
V_{UVLO}	IC active threshold voltage	V_{IN} rising	3.15	3.35	3.5	V
	IC active hysteresis	V_{IN} falling from above V_{UVLO}		175		mV
V_{SLP}	Sleep-mode entry threshold, $V_{IN\text{-}VBAT}$	2.0 V ≤ V_{BAT} ≤ V_{BATREG}, V_{IN} falling	0	50	100	mV
	Sleep-mode exit hysteresis, $V_{IN\text{-}VBAT}$	2.0 V ≤ V_{BAT} ≤ V_{BATREG}	40	100	160	mV
$t_{DGL(SLP)}$	Deglitch time for IN rising above VIN+VSLP_EXIT	Rising voltage, 2-mV over drive, t_{RISE} = 100 ns		32		ms
V_{OVP}	Input supply OVP threshold voltage	IN rising	Input OVP −200mV	Input OVP	Input OVP +200mV	V
	VOVP hysteresis	IN falling from V_{OVP}		100		mV
$t_{DGL(OVP)}$	Deglitch time for IN Rising above VOVP	IN rising voltage, t_{RISE} = 100 ns		32		ms
V_{BOVP}	Battery OVP threshold voltage	V_{BAT} threshold over V_{BATREG} to turn off charger during charge	102.5	105	107.5	% V_{BATREG}
	VBOVP hysteresis	Lower limit for V_{BAT} falling from above V_{BOVP}		1		% V_{BATREG}
$t_{DGL(BOVP)}$	BOVP Deglitch	Battery entering/exiting BOVP		1		ms

Electrical Characteristics (continued)

$V_{UVLO} < V_{IN} < V_{OVP}$ and $V_{IN} > V_{BAT}+V_{SLP}$, T_J = 0ºC-125°C and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
PWM CONVERTER						
$R_{ON(BLK)}$	Internal blocking MOSFET on-resistance	Measured from IN to PMID (WCSP & QFN)		60	100	mΩ
$R_{ON(HS)}$	Internal high-side MOSFET on-resistance	Measured from PMID to SW (WCSP & QFN)		100	150	mΩ
$R_{ON(LS)}$	Internal low-side MOSFET on-resistance	Measured from SW to PGND (WCSP & QFN)		110	165	mΩ
I_{CbC}	Cycle-by-cycle current limit	VSYS shorted	2.6	3.2	3.8	A
f_{OSC}	Oscillator frequency		2.7	3	3.3	MHz
D_{MAX}	Maximum duty cycle			95%		
D_{MIN}	Minimum duty cycle			0%		
T_{SHTDWN}	Thermal trip			150		°C
	Thermal hysteresis			10		
T_{REG}	Thermal regulation threshold	Charge current begins to cut off		125		
LDO (LINEAR DROPOUT)						
V_{LDO}	LDO Output Voltage	bq24251 and bq24253	V_{IN} = 5.5 V, I_{LDO} = 0 to 50 mA	4.65	4.95	5.25	V
I_{LDO}	Maximum LDO Output Current		50			mA
V_{DO}	LDO Dropout Voltage ($V_{IN} – V_{LDO}$)	V_{IN} = 5.0 V, I_{LDO} = 50 mA		200	300	mV
BATTERY-PACK NTC MONITOR (1)						
V_{HOT}	High temperature threshold	V_{TS} falling	29.6	30	30.4	
$V_{HYS(HOT)}$	Hysteresis on high threshold	V_{TS} rising		1		
V_{WARM}	Warm temperature threshold	V_{TS} falling	37.9	38.3	38.7	
$V_{HYS(WARM)}$	Hysteresis on warm temperature threshold	V_{TS} rising		1		
V_{COOL}	Cool temperature threshold	V_{TS} rising	56.1	56.5	56.9	% V_{LDO}
$V_{HSY(COOL)}$	Hysteresis on cool temperature threshold	V_{TS} falling		1		
V_{COLD}	Low temperature threshold	V_{TS} rising	59.6	60	60.4	
$V_{HYS(COLD)}$	Hysteresis on low threshold	V_{TS} falling		1		
V_{FRZ}	Freeze temperature threshold	V_{TS} rising	62	62.5	63	
$V_{HYS(FRZ)}$	Hysteresis on freeze threshold	V_{TS} falling		1		
V_{TS_DIS}	TS disable threshold		70		73	
$t_{DGL(TS)}$	Deglitch time on TS change			32		ms
INPUTS (EN1, EN2, EN2, $\overline{CE}$, CE1, CE2, BATREG, SCL, SDA, DBP)						
V_{IH}	Input high threshold		1			V
V_{IL}	Input low threshold				0.4	V
STATUS OUTPUTS ($\overline{CHG}$, $\overline{PG}$, STAT, INT, $\overline{BATRDY}$)						
V_{OL}	Low-level output saturation voltage	I_O = 5 mA, sink current			0.4	V
I_{IH}	High-level leakage current	Hi-Z and 5V applies			1	µA
TIMERS						
t_{SAFETY}	45 min safety timer			2700		s
	6 hr safety timer			21600		
	9 hr safety timer			32400		
$t_{WATCH-DOG}$	Watch dog timer			50		s

Electrical Characteristics (continued)

$V_{UVLO} < V_{IN} < V_{OVP}$ and $V_{IN} > V_{BAT}+V_{SLP}$, T_J = 0ºC-125°C and T_J = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
D+/D– DETECTION						
I_{DP_SRC}	D+ current source for DCD	DCD	7		13	µA
R_{DM_DWN}	D– pull-down resistance for DCD	DCD	14.25		24.8	kΩ
V_{DP_LOW}	D+ low comparator threshold for DCD	DCD	0.85	0.9	0.95	V
V_{DP_SRC}	D+ source voltage for Primary Detection	Primary Detection	0.5	0.6	0.7	V
$I_{DP\_SRC\_PD}$	D+ source voltage output current for Primary Detection	Primary Detection	200			µA
I_{DM_SINK}	D– sink current for Primary Detection	Primary Detection	50	100	150	µA
V_{DAT_REF}	Primary Detection threshold	Primary Detection	250	325	400	mV
V_{LGC}	Primary Detection threshold	Primary Detection	0.85	0.9	0.95	V
V_{DM_SRC}	D- source voltage for Secondary Detection	Secondary Detection	0.5	0.6	0.7	V
$I_{DM\_SRC\_PD}$	D- source voltage output current for Secondary Detection	Secondary Detection	200			µA
I_{DP_SINK}	D+ sink current for Secondary Detection	Secondary Detection	50	100	150	µA
V_{DAT_REF}	Secondary Detection threshold	Secondary Detection	250	325	400	mV
V_{ATT_LO}	Apple/TomTom detection low threshold	Apple/TomTom Detection	1.8	1.85	1.975	V
V_{ATT_HI}	Apple/TomTom detection high threshold	Apple/TomTom Detection	3.2	3.5	3.8	V
C_I	Input Capacitance	D– , switch open		4.5		pF
		D+, switch open		4.5		
I_{D_LKG}	Leakage Current into D+/D–	D–, switch open	−1		1	µA
		D+, switch open	−1		1	

8.6 Typical Characteristics

V_{BAT} = 3.8 V
I_{CHG} = 0.5 A
V_{IN} = 5 V
I_{LIM} = 1 A
V_{REG} = 4.2 V
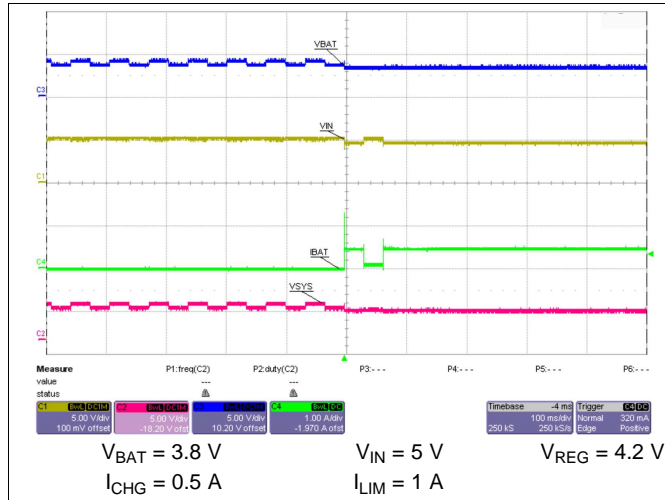
Figure 1. Battery Detection

V_{BAT} = 3.8 V
I_{CHG} = 1 A
V_{IN} = 6 V
I_{LIM} = 1 A
V_{REG} = 4.2 V
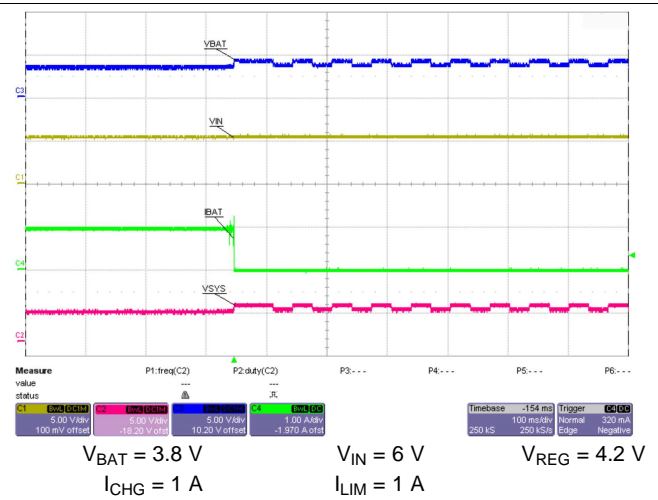
Figure 2. Battery Removal

I_{CHG} = 2 A
V_{IN} = 5 V
V_{REG} = 4.2 V
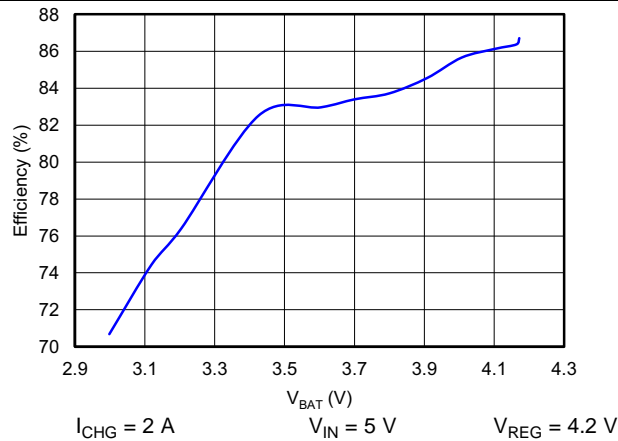
Figure 3. Efficiency vs Battery Voltage

V_{IN} = 5 V
V_{REG} = 4.2 V
No Battery
Charge Disable
I_{LIM} = 2 A
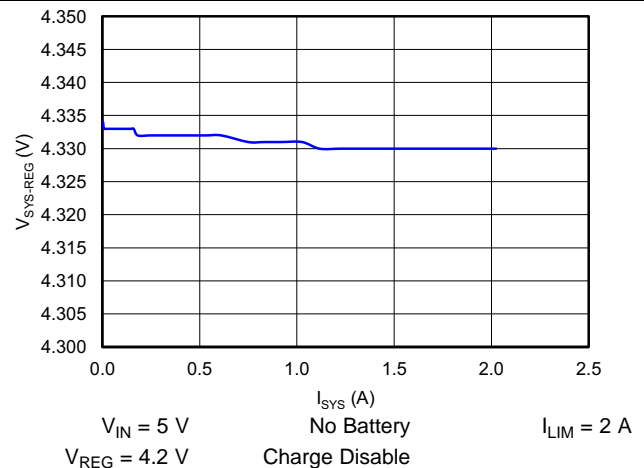
Figure 4. System Voltage Regulation vs Load Current

V_{REG} = 4.2 V
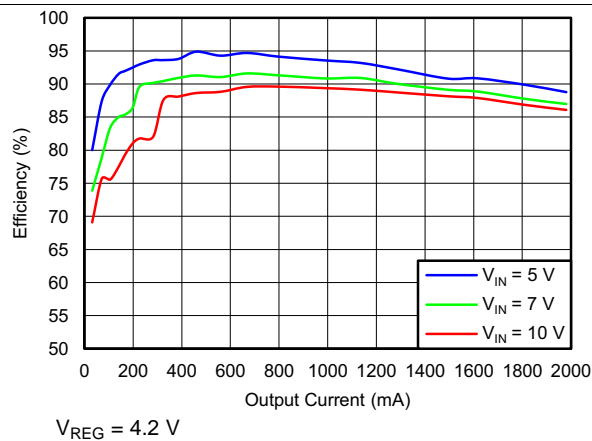
Figure 5. Efficiency vs Output Current

V_{REG} = 3.6 V
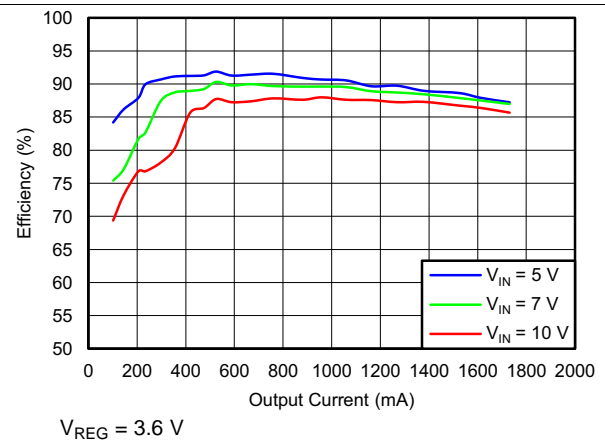
Figure 6. Efficiency vs Output Current

Typical Characteristics (continued)

V_{IN} = 0 V   SYSOFF = 0   Charge Enabled
                                        BAT & SYS are Shorted

Figure 7. BAT IQ, SYSOFF = 0

V_{IN} = 0 V   SYSOFF = 1   Charge Enabled
                                        BAT & SYS are Shorted

Figure 8. BAT IQ, SYSOFF = 1

Charge EN and DIS   No Battery and System
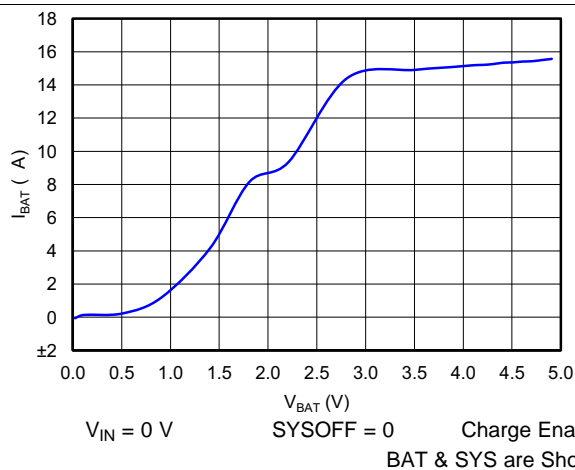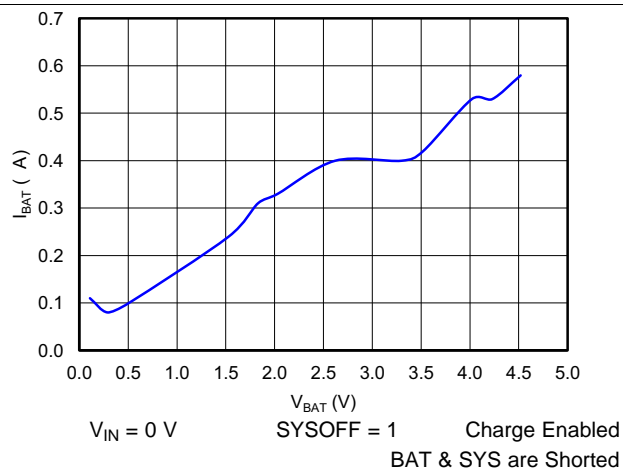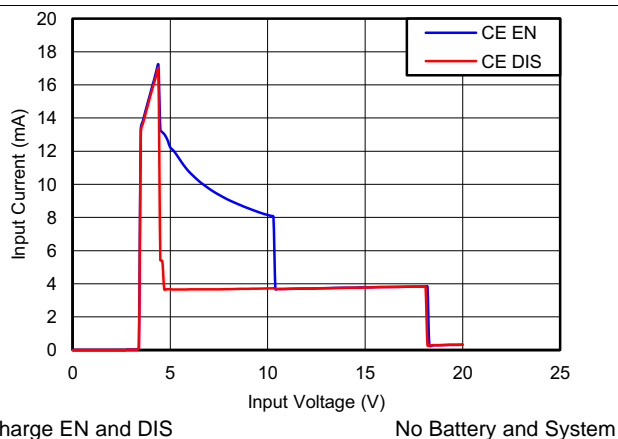
Figure 9. Input IQ With Charge DIS and EN

Charge EN   Hi-Z EN
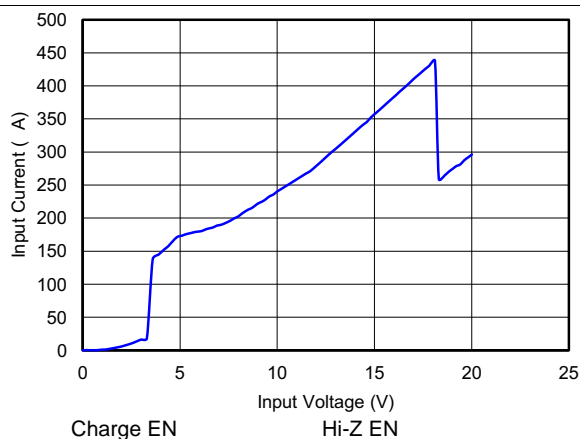
Figure 10. Input IQ with Charge Enable and Hi-Z

V_{BAT} = 3.3 V V_{IN} = 5 V V_{REG} = 4.2 V
                          I_{LIM} = 2 A
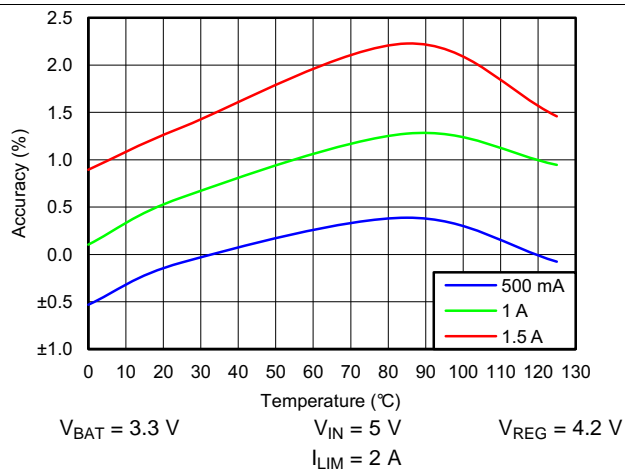
Figure 11. I_{CHG} Accuracy with Internal Settings, V_{BAT} = 3.3 V

V_{BAT} = 3.8 V V_{IN} = 5 V V_{REG} = 4.2 V
                          I_{LIM} = 2 A
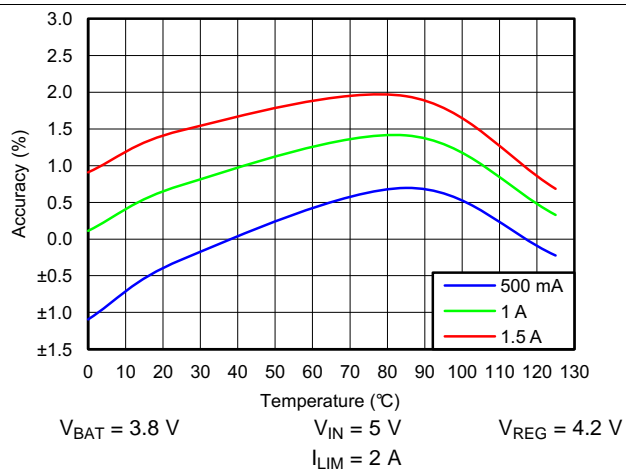
Figure 12. I_{CHG} Accuracy with Internal Settings, V_{BAT} = 3.8 V

Typical Characteristics (continued)

Figure 13. Ratio Between VILIM and IIN With External ILIM Control

$V_{BAT} = 3.9$ V
$I_{CHG} = 1$ A

$V_{OVP} = 10.5$ V
$I_{LIM} = 1$ A

Figure 14. Input OVP Event with INT
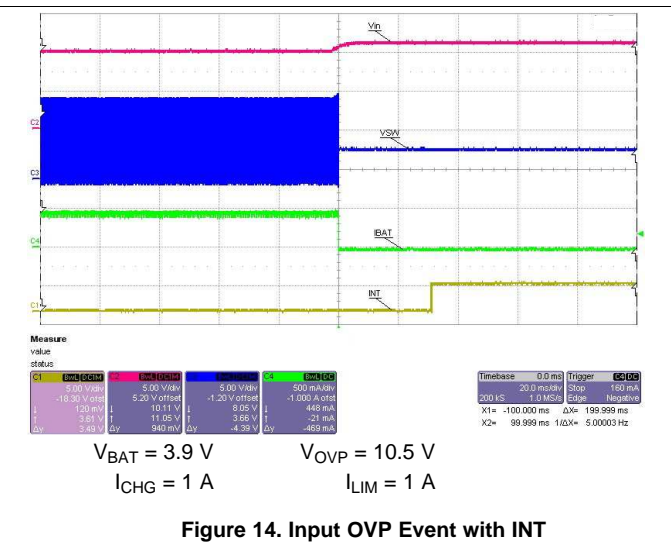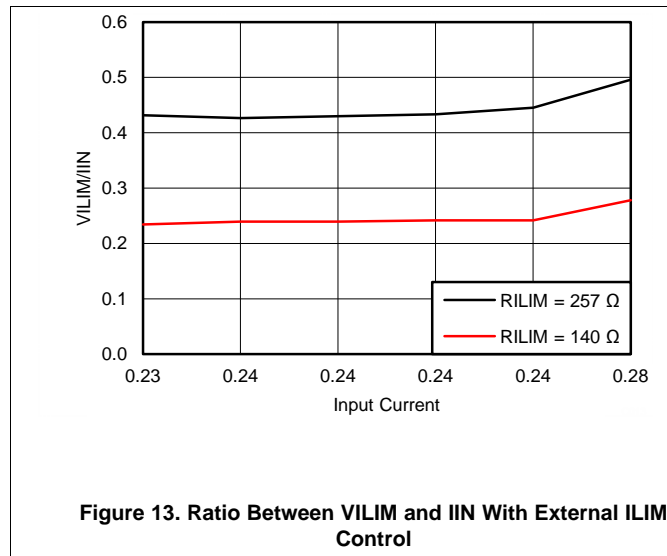
9 Detailed Description

9.1 Overview

The bq2425x is a highly-integrated, single-cell, Li-Ion battery charger with integrated current sense resistors targeted for space-limited, portable applications with high-capacity batteries. The single-cell charger has a single input that operates from either a USB port or AC wall adapter for a versatile solution.

9.2 Functional Block Diagram
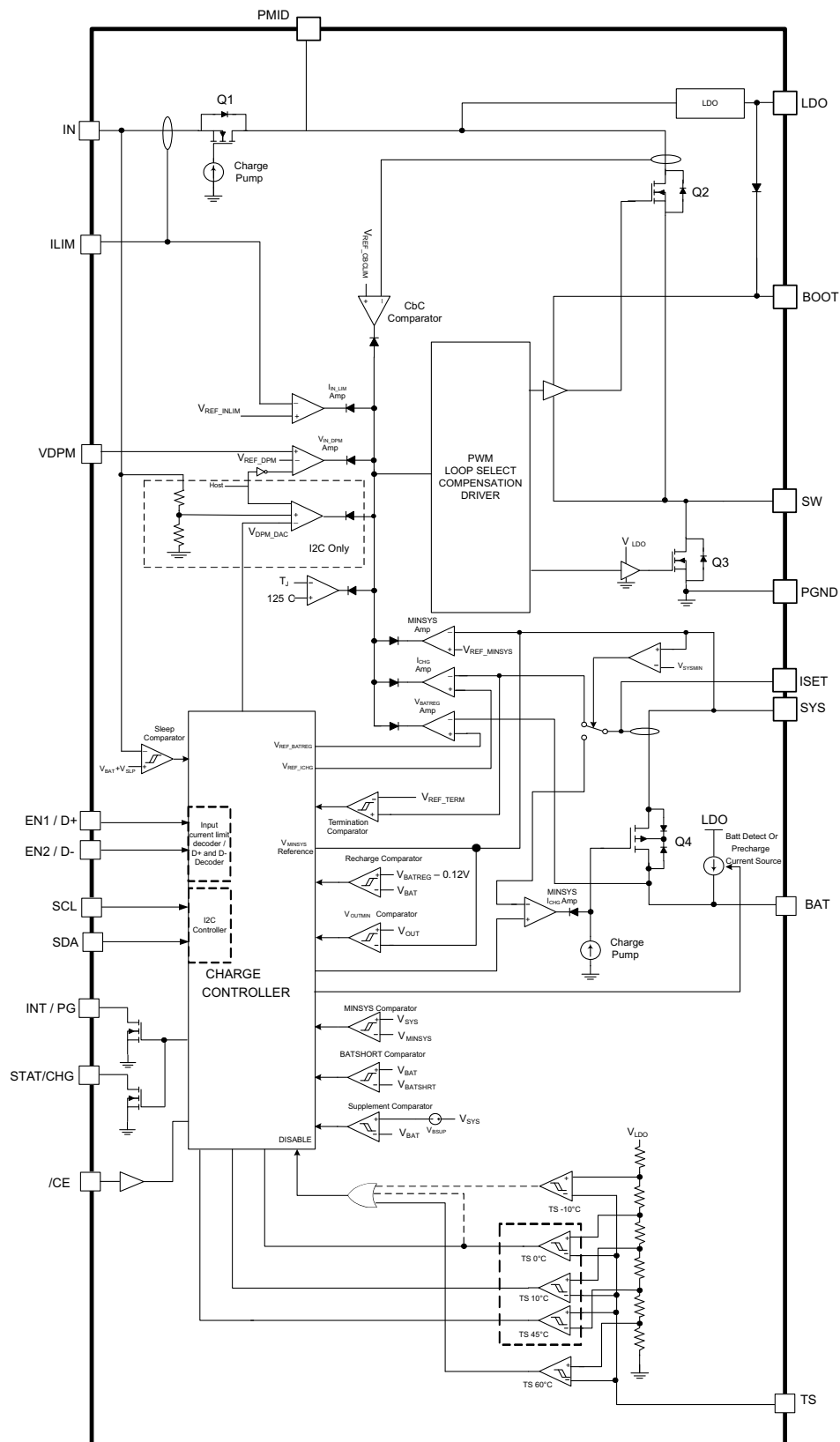
9.3 Feature Description

9.3.1 Charge Profile

The bq2425x family provides a switch-mode buck regulator with output power path and a charge controller to provide optimum performance over the full battery charge cycle. The control loop for the buck regulator has 7 primary feedback loops that can set the duty cycle:

1. Constant Current (CC)
2. Constant Voltage (CV)
3. Minimum System Voltage (MINSYS)
4. Input Current (I_{ILIM})
5. Input Voltage (V_{IN_DPM})
6. Die Temperature
7. Cycle by Cycle Current

The feedback with the minimum duty cycle will be chosen as the active loop. The bq24251 and bq24253 support a precision Li-Ion or Li-Polymer charging system for single-cell applications. The Dynamic Power Path Management (DPPM) feature regulates the system voltage to a minimum of V_{MINSYS}, so that startup is enabled even with a missing or deeply discharged battery. This provides a much better overall user experience in mobile applications. Figure 15 illustrates a typical charge profile while also demonstrating the minimum system output voltage regulation.
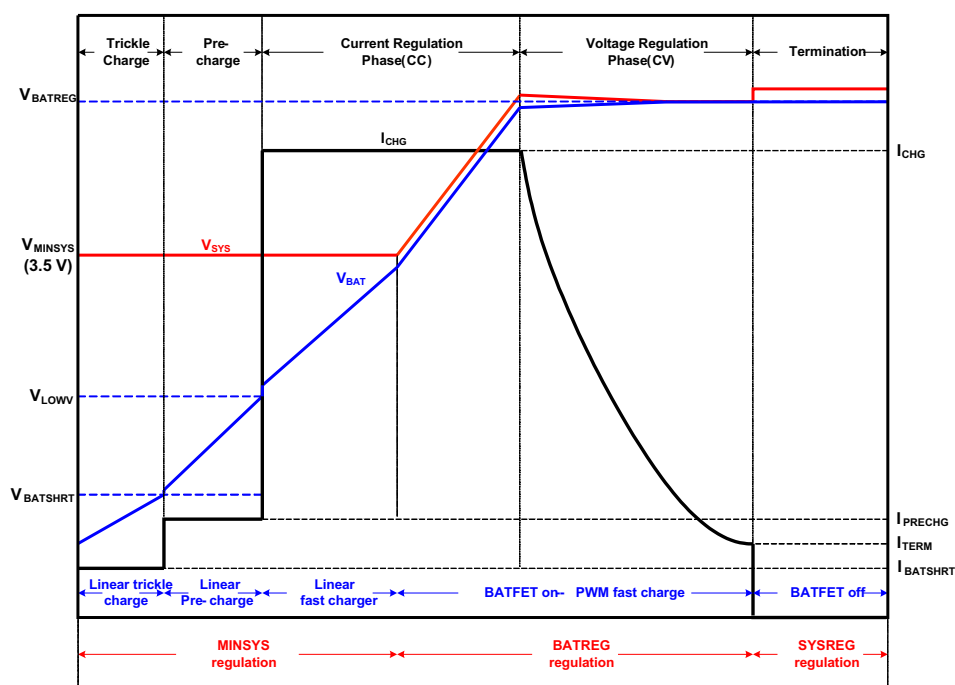
Figure 15. bq24250 Charge Profile and Minimum System Output Voltage Regulation

Figure 16 demonstrates a measured charge profile with the bq2425X while charging a 2700mAh Li-Ion battery at a charge rate of 1A.

Feature Description (continued)
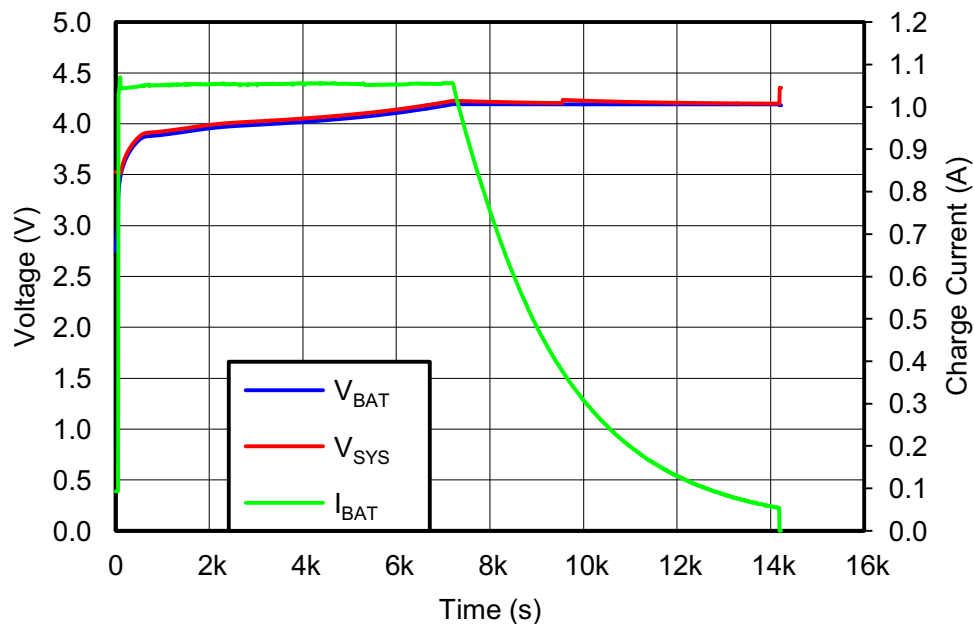
I_{CHG} = 1 A

Figure 16. bq24250 Charge Profile while Charging a 2700-mAh Battery at a 1A Charge Rate

Figure 17 illustrates the precharge behavior of the above charge profile by narrowing the time axis to 0 − 120 seconds.
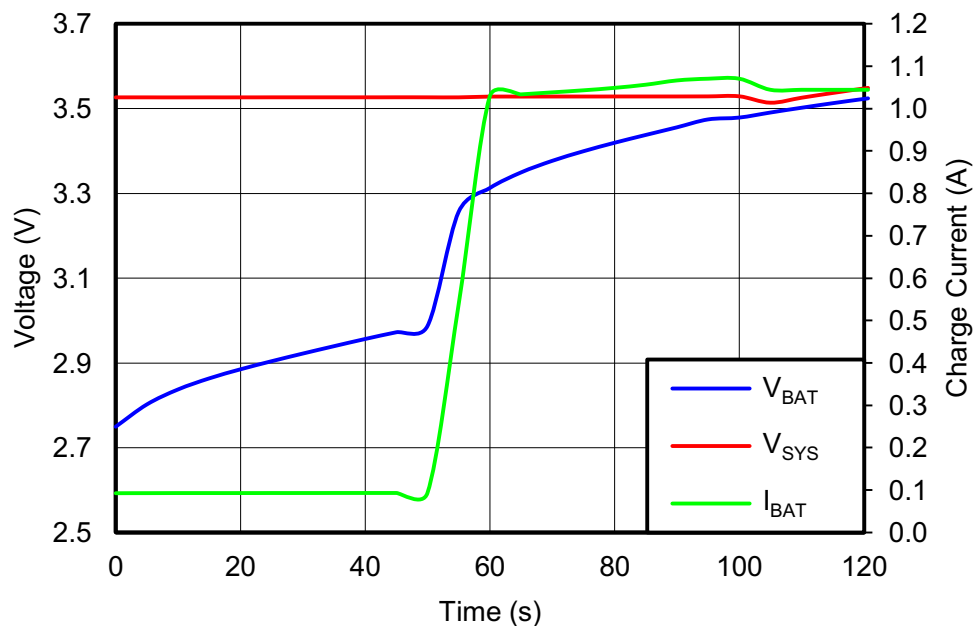
I_{CHG} = 1 A

Figure 17. bq24250 Charge Profile While Charging a 2700-mAh Battery at a 1A Charge During Precharge

Feature Description (continued)

9.3.2 EN1 and EN2 Pins

The bq24251 is an I^{2}C and stand-alone part. The EN1 and EN2 are not available for this spin but the D+/D- are available to support the BC1.2 D+/D- Based Adapter Detection. It detects DCP, SDP, and CDP. Also it complies with the unconnected dead battery provision clause. D+ and D- pins are connected to the D+ and D- outputs of the USB port at power up. Also includes the detection of Apple^{TM} and TomTom^{TM} adapters where a 500 mA input current limit is enabled. The $\overline{PG}$ pin will remain high impedance state until the detection is completed.

The bq24253 is a stand-alone part only. Both of the D+/D- and EN1/EN2 are available for this spin. During power up, the device checks first for the D+/D-. The EN1 and EN2 do not take effect until D+/D- detection routine is over and a change on the status of the EN1 and EN2 occurred.

When the input current limit pins change state, the V_{IN_DPM} threshold changes as well. See Table 1 for the detailed truth table:

Table 1. EN1 and EN2 Truth Table[1]

| EN2	EN1	Input Current Limit	V_{IN_DPM} Threshold
0	0	500mA	4.36V
0	1	Externally programmed by ILIM (up to 2.0A)	Externally programmed VDPM
1	0	100mA	4.36V
1	1	Input Hi-Z	None

(1) USB3.0 support available. Contact your local TI representative for details.

9.3.3 External Settings: ISET, ILIM and VIN_DPM

If the external resistor settings are used, the following equations can be followed to configure the charge settings.

The fast charge current resistor (R_{ISET}) can be set by using the following formula:

$$R_{ISET} = \frac{K_{ISET}}{I_{FC}} = \frac{250}{I_{FC}}$$

(1)

Where I_{FC} is the desired fast charge current setting in Amperes.

The input current limit resistor (R_{ILIM}) can be set by using the following formula:

$$R_{ILIM} = \frac{K_{ILIM}}{I_{IC}} = \frac{270}{I_{IC}}$$

(2)

Where I_{IC} is the desired input current limit in Amperes.

Based on the application diagram reference designators, the resistor R1 and R2 can be calculated as follows to set V_{IN_DPM}:

$$V_{IN\_DPM} = V_{REF\_DPM} \times \frac{R_1 + R_2}{R_2} = 1.2V \times \frac{R_1 + R_2}{R_2}$$

(3)

V_{IN_DPM} should be chosen first along with R_1. Choosing R_1 first will ensure that R_2 will be greater than the resistance chosen. This is the case since V_{IN_DPM} should be chosen to be greater than 2x V_{REF_DPM}.

If external resistors are not desired in order to reduce the BOM count, the VDPM and the ILIM pins can be shorted to set the internal defaults. The ISET resistor must be connected in order to avoid an unstable charging state. Note that floating the ILIM pin will result in zero charge current if the external ISET is configured via the I^{2}C register. Table 2 summarizes the settings when the ILIM, ISET, and V_{IN_DPM} pins are shorted to GND:

Table 2. ILIM, VDPM, and ISET Short Behaviors

PIN SHORTED	BEHAVIOR
ILIM	Input current limit = 2A
VDPM	V_{IN_DPM} = 4.68V
ISET	Fault—Charging Suspended

9.3.4 BC1.2 D+/D– Detection

The bq24251 and the bq24253 include a fully BC1.2 compatible D+/D– source detection. This detection supports the following types of ports:

- DCP (dedicated charge port)
- CDP (charging downstream port)
- SDP (standard downstream port)
- Apple™/TomTom™ ports

This D+/D– detection algorithm does not support ACA (accessory charge adapter) identification, but the input current will default to 500 mA when a charge port is attached to the ACA and bq24251/3 is connected to the OTG port.

The D+/D– detection algorithm is only active when the device is in standalone mode (e.g. the host is not communicating with the device and the watch dog timer has expired). However, when the device is in host mode (e.g. host is communicating via I^{2}C to the device) writing a '1' to register 0x04 bit location 4 (DPDM_EN) forces the device to perform a D+/D– detection. This allows the D+/D– detection to be enabled in both host mode and default mode. The current limit will not be implemented in host mode.

As described previously, the bq24253 is a stand-alone part only. Both of the D+/D- and EN1/EN2 are available for this spin. The below flow diagram illustrates the behavior of the bq24253 in D+/D- detection and the effect of the EN1/EN2. During power up, the device checks first for the D+/D-. The EN1 and EN2 do not take effect until D+/D- detection routine is over and a change on the status of the EN1 and EN2 occurred.
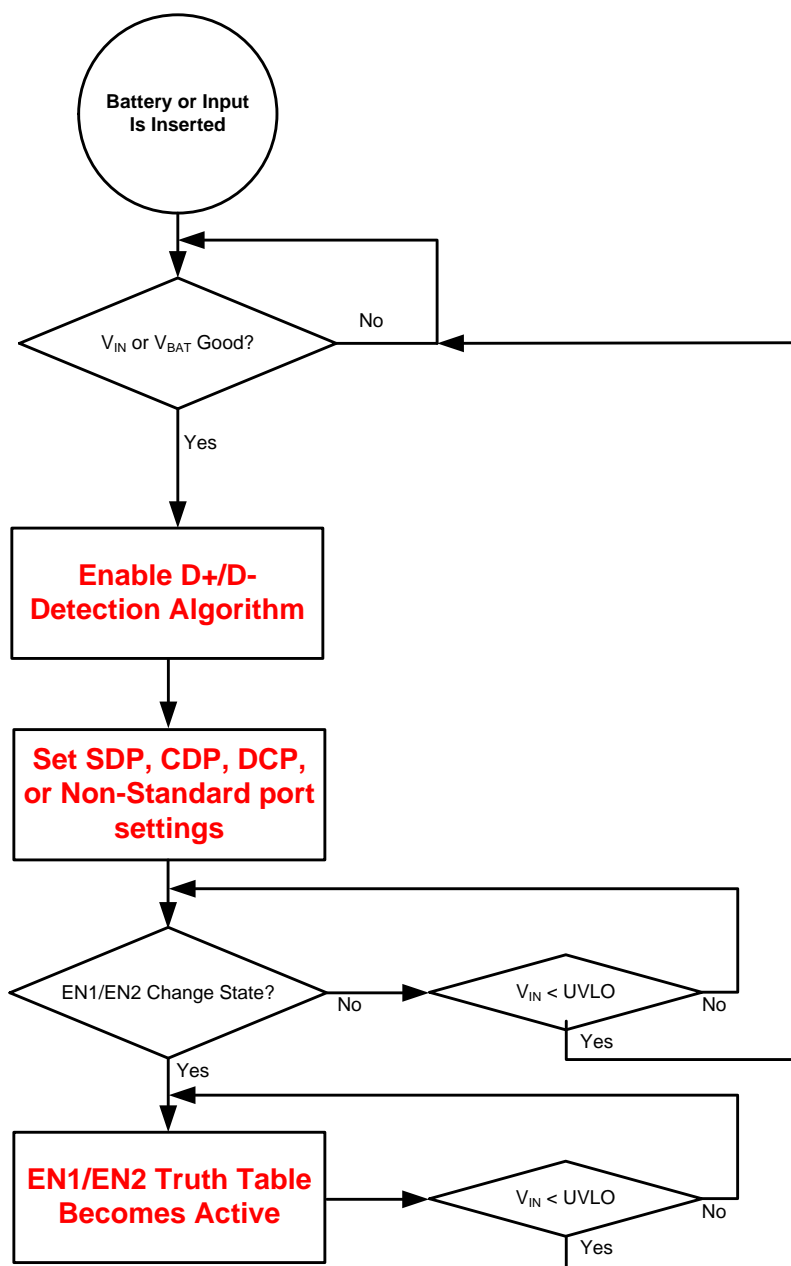
Figure 18. bq24253 D+/D- and EN1/EN2

The D+/D– detection algorithm has 5 primary states. These states are termed the following:

1. Data Contact Detect
2. Primary Detection
3. Secondary Detection
4. Non-standard Adapter Detection (for Apple™ / TomTom™)
5. Detection Configuration

The DCD state determines if the device has properly connected to the D+/D– lines. If the device is not in host mode and VBUS is inserted (or DPDM_EN is true) the device enters the DCD state and enable the appropriate algorithm. If the DCD timer expires, the device enters the Non-standard Adapter Detection (for Apple™ / TomTom™) state. Otherwise it enters the Primary Detection state.

22

When entering the Primary Detection state, the appropriate algorithm is enabled to determine whether to enter the secondary detection state for DCP and CDP or the secondary detection state for SDP/Non-Standard adaptors.

The non-standard adapter detection state for Apple™ / TomTom™ tests for the unique conditions for these non-standard adapters. If the algorithm passes the unique conditions found with these adapters, it proceeds to the Detection Configuration state. Otherwise it reverts back to the primary detection state.

The secondary detection state determines whether the input port is a DCP, CDP, SDP, or other non-standard adapters. If the Primary Detection state indicated that the input port is either a DCP or CDP, the device enables the appropriate algorithm to differentiate between the two. If the Primary Detection state indicated that the input port is either a SDP or non-standard adapter, the device enables the appropriate algorithm to differentiate between these two ports. Once complete, the device continues to the Detection Configuration state.
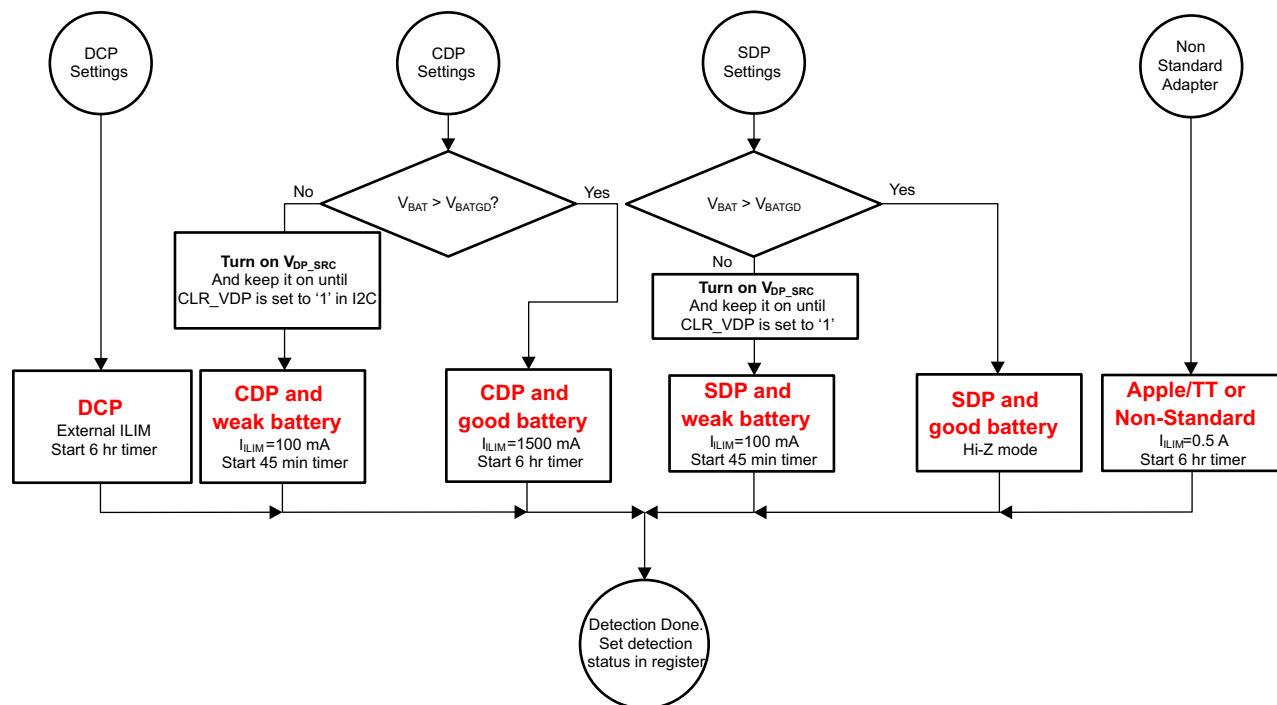
Figure 19. Detection Configuration State

The detection configuration state sets the input current limit of the device along with the charge timer. The exception to the CDP and the SDP settings are due to the Dead Battery Provision (DBP) clause for unconnected devices. This clause states that the device can pull a maximum of 100mA when not connected due to a dead battery. During the battery wakeup time, the device sources a voltage on the D+ pin in order to comply with the DBP clause. Once the battery is good, the system can clear the D+ pin voltage by writing a '1' to address 0x07 bit position 4 (CLR_VDP). The device must connect to the host within 1sec of clearing the D+ pin voltage per the DPB clause.

A summary of the input current limits and timer configurations for each charge port type are found in Table 3.

Table 3. D+/D– Detection Results per Charge Port Type

CHARGE PORT TYPE	INPUT CURRENT LIMIT	CHARGE TIMER
DCP	External ILIM	6 hours
CDP Dead Battery	100 mA	45 minutes
CDP Good Battery	1500 mA	6 hours
SDP Dead Battery	100 mA	45 minutes
SDP Good Battery	Hi-Z	N/A
Non-Standard	500 mA	6 hours

9.3.5 Transient Response

The bq24251 and bq24253 include an advanced hybrid switch mode control architecture. When the device is regulating the charge current (fast-charge), a traditional voltage mode control loop is used with a Type-3 compensation network. However, the bq24251 and bq24253 switch to a current-mode control loop when the device enters voltage regulation. Voltage regulation occurs in three charging conditions: 1) Minimum system voltage regulation (battery below MINSYS), 2) Battery voltage regulation ($I_{BAT} < I_{CHG}$), and 3) Charge Done (V_{SYS} = V_{BAT} + 3.5%). This architecture allows for superior transient performance when regulating the voltage due to the simplification of the compensation when using current mode control. The below transient response plot illustrates a 0A to 2A load step with 4.7 ms full cycle and 12% duty cycle. A 3.9 V Li-Ion battery is used. The input voltage is set to 5 V, charge current is set to 0.5 A and the input current is limited to 0.5 A. Note that a high line impedance input supply was used to indicate a realistic input scenario (adapter and cable). This is illustrated by the change in V_{IN} seen at the input of the IC.

Figure 33 shows a ringing at both the input voltage and the input current. This is caused by the input current limit speed up comparator.

9.3.6 *AnyBoot* Battery Detection

The bq2425x family includes a sophisticated battery detection algorithm used to provide the system with the proper status of the battery connection. The AnyBoot battery algorithm also guarantees the detection of voltage based battery protectors that may have a long closure time (due to the hysteresis of the protection switch and the cell capacity). The AnyBoot battery detection algorithm utilizes a dual-voltage based detection methodology where the system rail switches between two primary voltage levels. The period of the voltage level shift is 64ms and therefore the power supply rejection of the down-system electronics detects this shift as essentially DC.

The AnyBoot algorithm has essentially 3 states. The 1st state is used to determine if the device has terminated with a battery attached. If it has terminated due to the battery not being present, then the algorithm moves to the 2nd and 3rd states. The 2nd and 3rd states shift the system voltage level between 4.2 V and 3.72 V. In each state there are comparator checks to determine if a battery has been inserted. The two states guarantees the detection of a battery even if the voltage of the cell is at the same level of the comparator thresholds. The algorithm will remain in states 2 and 3 until a battery has been inserted. The flow diagram details for the Anyboot algorithm are shown in Figure 20.

Enter Battery Detection

BATREG = V$_{reg}$ setting – 480 mV

V$_{BAT}$ > BATREG+120 mV? — Yes → 32 ms Timer Expired? — No → **Battery Detected, STAT register updated, and PTM mode aborted (if enabled)** (Yes)

No ↓

32 ms Timer Expired? — No ↑ / Yes ↓

BATREG = 4.2 V

VBAT < 4.08 V? — Yes → 32 ms Timer Expired? — No → **Battery Detected, STAT register updated and Exit Battery Detection** (Yes)

No ↓

32ms Timer Expired? — No ↑ / Yes ↓

ONLY ON FIRST LOOP ITERATION
"No Battery" Condition
BATREG = 4.2 V
Update STAT Registers and send Fault Pulse

Force PTM = 1? — Yes → **Enter PTM mode Exit Battery Detection**

No ↓

BATREG = 3.72 V

V$_{BAT}$ > 3.84 V? — Yes → 32 ms Timer Expired? — No → **Battery Detected, STAT register updated and Exit Battery Detection** (Yes)

No ↓

32 ms Timer Expired? — No ↑ / Yes ↓

Figure 20. AnyBoot Battery Detection Flow Diagram

9.3.7 Input Voltage Based DPM

During normal charging process, if the input power source is not able to support the programmed or default charging current, the supply voltage deceases. Once the supply drops to VIN_DPM, the input current limit is reduced down to prevent the further drop of the supply. When the IC enters this mode, the charge current is lower than the set. This feature ensures IC compatibility with adapters with different current capabilities without a hardware change.

9.3.8 Sleep Mode

The bq2425x enters the low-power sleep mode if the voltage on VIN falls below sleep-mode entry threshold, VBAT+VSLP, and VIN is higher than the under-voltage lockout threshold, VUVLO. This feature prevents draining the battery during the absence of VIN. When VIN < VBAT+VSLP, the bq2425x turns off the PWM converter, turns on the battery FET, sends a single 256-µs pulse on the STAT and INT outputs and the FAULT/STAT bits of the status registers are updated in the I^{2}C. Once VIN > VBAT+VSLP with the hysteresis, the FAULT bits are cleared and the device initiates a new charge cycle.

9.3.9 Input Over-Voltage Protection

The bq2425x provides over-voltage protection on the input that protects downstream circuitry. The built-in input over-voltage protection to protect the device and other components against damage from overvoltage on the input supply (Voltage from VIN to PGND). When VIN > VOVP, the bq2425x turns off the PWM converter, turns on the battery FET, sends a single 256-µs pulse on the STAT and INT outputs and the FAULT/STAT bits of the status registers and the battery/supply status registers are updated in the I^{2}C. Once the OVP fault is removed, the FAULT bits are cleared and the device returns to normal operation.

9.3.10 NTC Monitor

The bq24251 and bq24253 include the integration of an NTC monitor pin that complies with the JEITA specification (PSE also available upon request). The voltage based NTC monitor allows for the use of any NTC resistor with the use of the circuit shown in Figure 21.
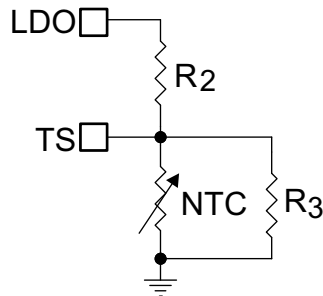
Figure 21. Voltage Based NTC Circuit

The use of R3 is only necessary when the NTC does not have a beta near 3500K. When deviating from this beta, error will be introduced in the actual temperature trip thresholds. The trip thresholds are summarized below which are typical values provided in the specification table.

Table 4. Ratiometric TS Trip Thresholds for JEITA Compliant Charging

TS THRESHOLDS	V$_{TS}$/V$_{LDO}$
V$_{HOT}$	30.0%
V$_{WARM}$	38.3%
V$_{COOL}$	56.5%
V$_{COLD}$	60%

When sizing for R2 and R3, it is best to solve two simultaneous equations that ensure the temperature profile of the NTC network will cross the V_{HOT} and V_{COLD} thresholds. The accuracy of the V_{WARM} and V_{COOL} thresholds will depend on the beta of the chosen NTC resistor. The two simultaneous equations are shown below:

$$\%V_{COLD} = \frac{\left(\dfrac{R_3 R_{NTC}|_{TCOLD}}{R_3 + R_{NTC}|_{TCOLD}}\right)}{\left(\dfrac{R_3 R_{NTC}|_{TCOLD}}{R_3 + R_{NTC}|_{TCOLD}}\right) + R2} \times 100$$

$$\%V_{HOT} = \frac{\left(\dfrac{R_3 R_{NTC}|_{THOT}}{R_3 + R_{NTC}|_{THOT}}\right)}{\left(\dfrac{R_3 R_{NTC}|_{THOT}}{R_3 + R_{NTC}|_{THOT}}\right) + R2} \times 100$$

(4)

Where the NTC resistance at the V_{HOT} and V_{COLD} temperatures must be resolved as follows:

$$R_{NTC}|_{TCOLD} = R_o e^{\beta\left(\frac{1}{TCOLD} - \frac{1}{To}\right)}$$

$$R_{NTC}|_{THOT} = R_o e^{\beta\left(\frac{1}{THOT} - \frac{1}{To}\right)}$$

(5)

To be JEITA compliant, T_{COLD} must be 0°C and T_{HOT} must be 60°C. If an NTC resistor is chosen such that the beta is 4000K and the nominal resistance is 10 kΩ, the following R2 and R3 values result from the above equations:

R_2 = 5 kΩ
R_3 = 9.82 kΩ

Figure 22 illustrates the temperature profile of the NTC network with R2 and R3 set to the above values.
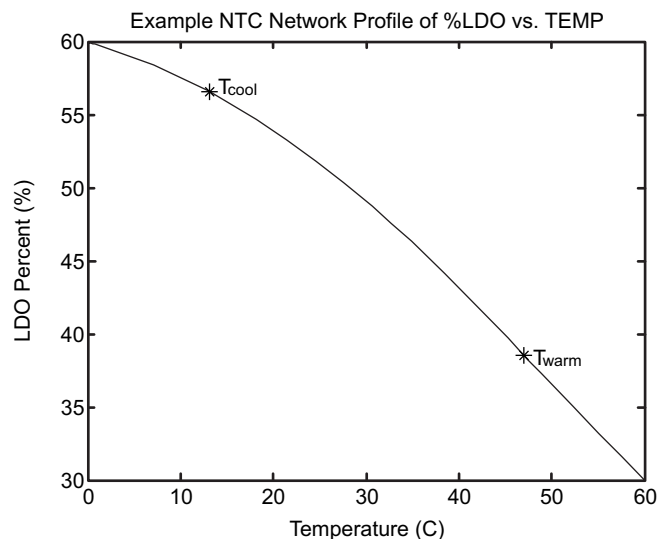
Figure 22. Voltage Based NTC Circuit Temperature Profile

For JEITA compliance, the T_{COOL} and T_{WARM} levels are to be 10°C and 45°C respectively. However, there is some error due to the variation in beta from 3500K. As shown above, the actual temperature points at which the NTC network crosses the V_{COOL} and V_{WARM} are 13°C and 47°C respectively. This error is small but should be considered when choosing the final NTC resistor.

Once the resistors are configured, the internal JEITA algorithm applies the profile shown in Figure 23 at each trip point for battery voltage regulation and charge current regulation. In order to ensure continuation of the charge process when an almost-full battery stops charging due to a cold temperature fault, it is recommended that a CE toggle is done on the I2C or CE pin.
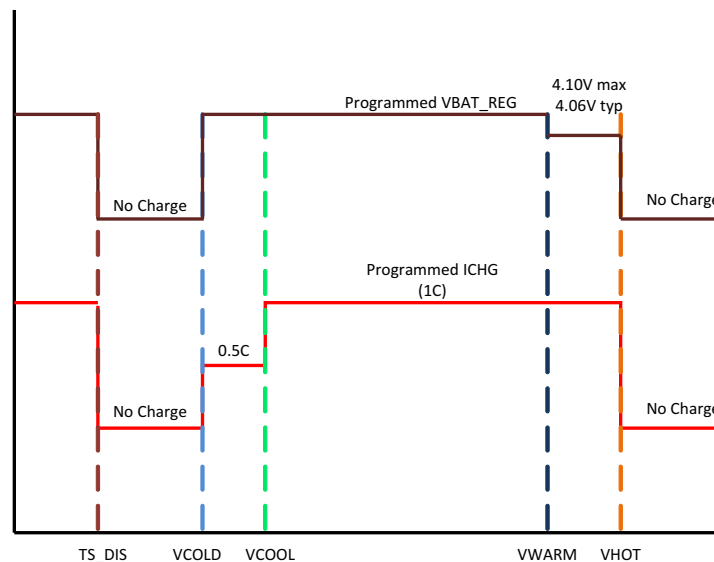
Figure 23. JEITA Profile for Voltage and Current Regulation Loops

9.3.11 Production Test Mode

To aid in end mobile device product manufacturing, the bq2425x includes a Production Test Mode (PTM), where the device is essentially a DC-DC buck converter. In this mode the input current limit to the charger is disabled and the output current limit is limited only by the inductor cycle-by-cycle current (e.g. 3.5A). The PTM mode can be used to test systems with high transient loads such as GSM transmission without the need of a battery being present.

As a means of safety, the Anyboot algorithm will determine if a battery is not present at the output prior to enabling the PTM mode. If a battery is present and the software attempts to enter PTM mode, the device will not enable PTM mode.

9.3.12 Safety Timer

At the beginning of charging process, the bq2425x starts the safety timer. This timer is active during the entire charging process. If charging has not terminated before the safety timer expires, the IC enters suspend mode where charging is disabled. The safety timer time is selectable using the I²C interface. A single 256μs pulse is sent on the STAT and INT outputs and the FAULT/ bits of the status registers are updated in the I²C. This function prevents continuous charging of a defective battery if the host fails to reset the safety timer. When 2xTMR_EN bit is set to "1", the safety timer runs at a rate 2x slower than normal (the timer is extended) under the following conditions:

- Pre-charge or linear mode (minimum system voltage mode),
- During thermal regulation where the charge current is reduced,
- During TS fault where the charge current is reduced due to temperature rise on the battery, input current limit

The safety timer is suspended during OVP, TS fault where charge is disabled, thermal shut down, and sleep mode. Removing the battery causes the safety timer to be reset and NOT halted/paused.

9.3.13 Watchdog Timer

In addition to the safety timer, the bq24251 contains a 50-second watchdog timer that monitors the host through the I2C interface. Once a write is performed on the I2C interface, a watchdog timer is reset and started. The watchdog timer can be disabled by writing "0" on WD_EN bit of register #1. Writing "1" on that bit enables and resets the timer.

If the watchdog timer expires, the IC enters DEFAULT mode where the default charge parameters are loaded and charging continues. The I2C may be accessed again to re-initialize the desired values and restart the watchdog timer as long as the safety timer has not expired. Once the safety timer expires, charging is disabled.

9.3.14 Fault Modes

The bq2425x family includes several hardware fault detections. This allows for specific conditions that could cause a safety concern to be detected. With this feature, the host can be alleviated from monitoring unsafe charging conditions and also allows for a "fail-safe" if the host is not present. The table below summarizes the faults that are detected and the resulting behavior.

FAULT CONDITION	CHARGER BEHAVIOR	SAFETY TIMER BEHAVIOR
Input OVP	VSYS and ICHG Disabled	Suspended
Input UVLO	VSYS and ICHG Disabled	Reset
Sleep (VIN < VBAT)	VSYS and ICHG Disabled	Suspended
TS Fault (Batter Over Temp)	VSYS Active and ICHG Disabled	Suspended
Thermal Shutdown	VSYS and ICHG Disabled	Suspended
Timer Fault	VSYS Active and ICHG Disabled	Reset
No Battery	VSYS Active and ICHG Disabled	Suspended
ISET Short	VSYS Active and ICHG Disabled	Suspended
Input Fault & LDO Low	VSYS and ICHG Disabled	Suspended

9.3.15 Dynamic Power Path Management

The bq24251 and bq24253 feature a SYS output that powers the external system load connected to the battery. This output is active whenever a valid source is connected to IN or BAT. The following discusses the behavior of SYS with a source connected to the supply or a battery source only.

When a valid input source is connected to the input and the charge is enabled, the charge cycle is initiated. In case of VBAT > ~3.5V, the SYS output is connected to VBAT. If the SYS voltage falls to VMINSYS, it is regulated to the VSYSREG threshold to maintain the system output even with a deeply discharged or absent battery. In this mode, the SYS output voltage is regulated by the buck converter and the battery FET is linearly regulated to regulate the charge current into the battery. The current from the supply is shared between charging the battery and powering the system load at SYS.

The dynamic power path management (DPPM) circuitry of the bq2425x monitors the current limits continuously and if the SYS voltage falls to the VMINSYS voltage, it adjusts charge current to maintain the minimum system voltage and supply the load on SYS. If the charge current is reduced to zero and the load increases further, the bq2425x enters battery supplement mode. During supplement mode, the battery FET is turned on and the battery supplements the system load.

If the battery is ever 5% above the regulation threshold, the battery OVP circuit shuts the PWM converter off and the battery FET is turned on to discharge the battery to safe operating levels. Battery OVP FAULT is shown in the I2C FAULT registers.

When no input source is available at the input and the battery is connected, the battery FET is turned on similar to supplement mode. The battery must be above VBATUVLO threshold to turn on the SYS output. In this mode, the current is not regulated; however, there is a short circuit current limit. If the short circuit limit is reached, the battery FET is turned off for the deglitch time. After the deglitch time, the battery FET is turned on to test and see if the short has been removed. If it has not, the FET turns off and the process repeats until the short is removed. This process is to protect the internal FET from over current.

9.4 Device Functional Modes

9.4.1 I²C Operation (Host Mode / Default Mode)

There are two primary modes of operation when interacting with the charge parameters of the bq24251 chargers: 1) *Host mode* operation where the I²C registers set the charge parameters, and 2) *Default mode* where the register defaults set the charge parameters.

Figure 24 illustrates the behavior of the bq24251 when transitioning between host mode and stand alone mode:
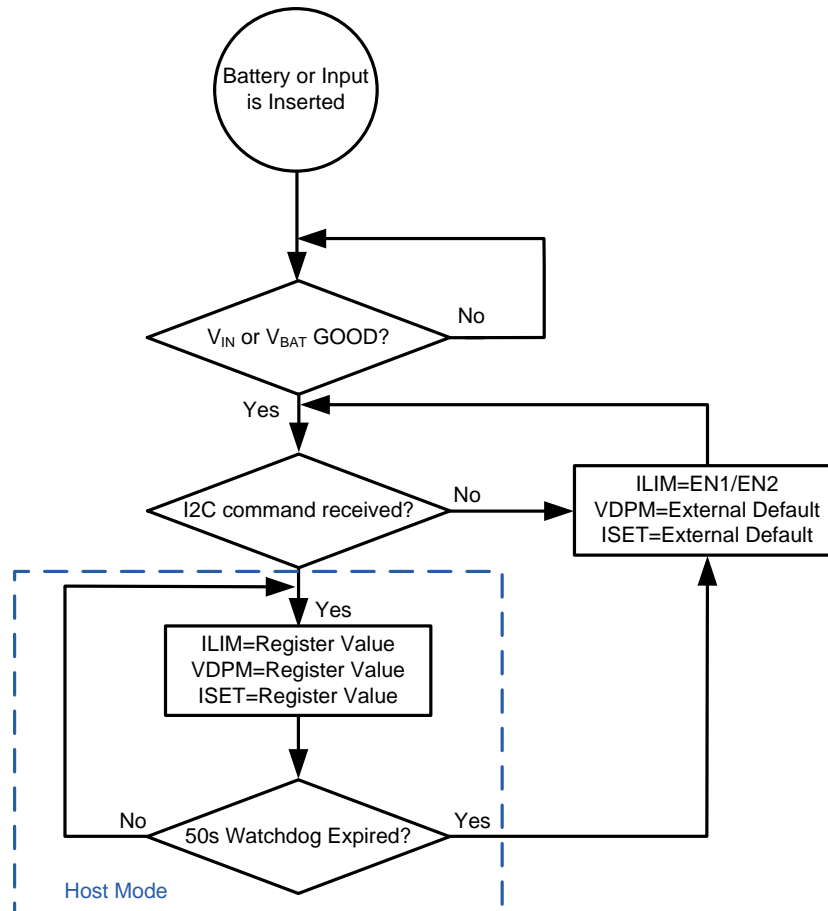
Figure 24. Host Mode and Stand Alone Mode Handoff

Once the battery or input is inserted and above the good thresholds, the device determines if an I²C command has been received in order to discern whether to operate from the I²C registers or the internal register defaults. In stand-alone mode the input current limit is set by the EN1/EN2 pins. If the watch dog timer is enabled, the device will enter stand alone operation once the watchdog timer expires and re-initiate the default charge settings.

9.5 Programming

9.5.1 Serial Interface Description

The bq2425x uses an I^{2}C compatible interface to program charge parameters. I^{2}C ™ is a 2-wire serial interface developed by NXP (formerly Philips Semiconductor, see I^{2}C-Bus Specification, Version 5, October 2012). The bus consists of a data line (SDA) and a clock line (SCL) with pull-up structures. When the bus is idle, both SDA and SCL lines are pulled high. All the I^{2}C compatible devices connect to the I^{2}C bus through open drain I/O pins, SDA and SCL. A master device, usually a microcontroller or a digital signal processor, controls the bus. The master is responsible for generating the SCL signal and device addresses. The master also generates specific conditions that indicate the START and STOP of data transfer. A slave device receives and/or transmits data on the bus under control of the master device.

The bq2425x device works as a slave and supports the following data transfer modes, as defined in the I^{2}C Bus™ Specification: standard mode (100 kbps) and fast mode (400 kbps). The interface adds flexibility to the battery charge solution, enabling most functions to be programmed to new values depending on the instantaneous application requirements. The I^{2}C circuitry is powered from IN when a supply is connected.

The data transfer protocol for standard and fast modes is exactly the same; therefore, they are referred to as the F/S-mode in this document. The bq24251 device only supports 7-bit addressing. The device 7-bit address is defined as '1101010' (0x6Ah).

To avoid I^{2}C hang-ups, a timer (t$_{I2CRESET}$) runs during I2C transactions. If the transaction takes longer than t$_{I2CRESET}$, any additional commands are ignored and the I2C engine is reset. The timeout is reset with START and repeated START conditions and stops when a valid STOP condition is sent.

9.5.1.1 F/S Mode Protocol

The master initiates data transfer by generating a start condition. The start condition is when a high-to-low transition occurs on the SDA line while SCL is high, as shown in Figure 25. All I^{2}C -compatible devices should recognize a start condition.
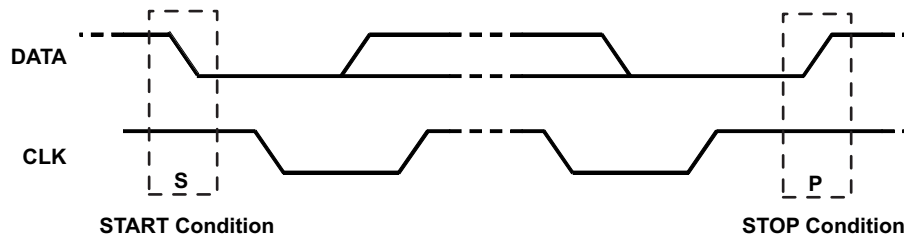
Figure 25. START and STOP Condition

The master then generates the SCL pulses, and transmits the 7-bit address and the read/write direction bit R/W on the SDA line. During all transmissions, the master ensures that data is valid. A valid data condition requires the SDA line to be stable during the entire high period of the clock pulse (see Figure 26). All devices recognize the address sent by the master and compare it to their internal fixed addresses. Only the slave device with a matching address generates an acknowledge (see Figure 27) by pulling the SDA line low during the entire high period of the ninth SCL cycle. Upon detecting this acknowledge, the master knows that communication link with a slave has been established.
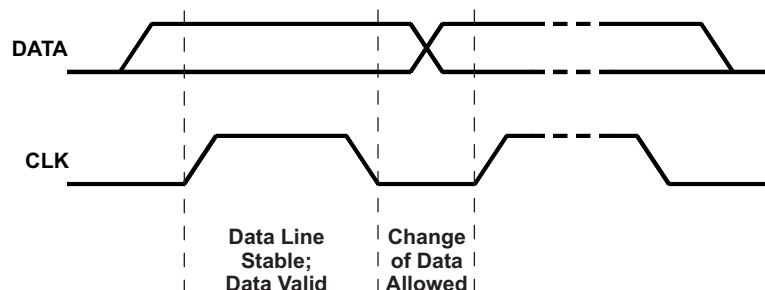
Figure 26. Bit Transfer on the Serial Interface

Programming (continued)

The master generates further SCL cycles to either transmit data to the slave (R/W bit 0) or receive data from the slave (R/W bit 1). In either case, the receiver needs to acknowledge the data sent by the transmitter. So an acknowledge signal can either be generated by the master or by the slave, depending on which one is the receiver. The 9-bit valid data sequences consisting of 8-bit data and 1-bit acknowledge can continue as long as necessary. To signal the end of the data transfer, the master generates a stop condition by pulling the SDA line from low to high while the SCL line is high (see Figure 25). This releases the bus and stops the communication link with the addressed slave. All I2C compatible devices must recognize the stop condition. Upon the receipt of a stop condition, all devices know that the bus is released, and wait for a start condition followed by a matching address. If a transaction is terminated prematurely, the master needs to send a STOP condition to prevent the slave I2C logic from remaining in a incorrect state. Attempting to read data from register addresses not listed in this section will result in 0xFFh being read out.
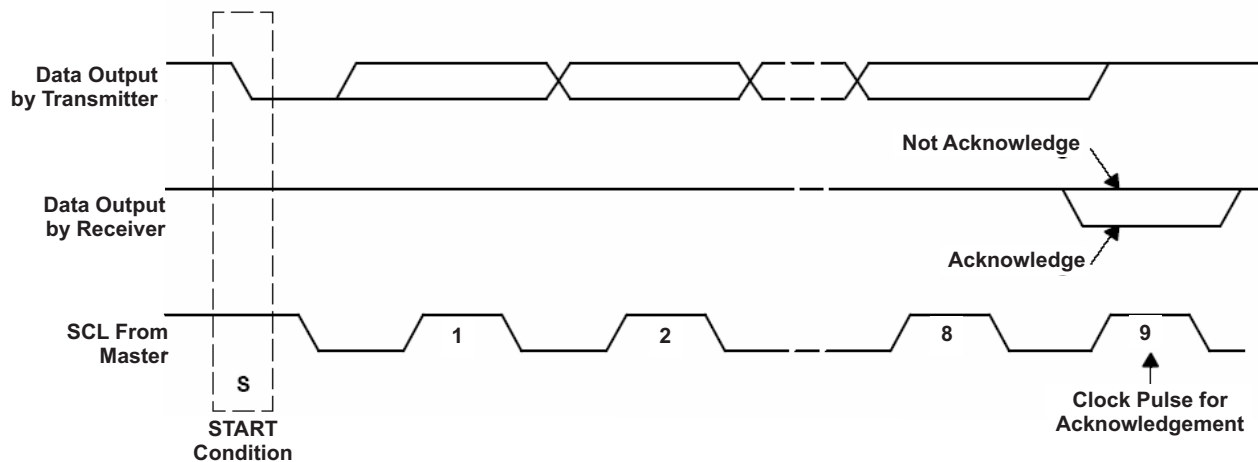
Figure 27. Acknowledge on the I2C Bus
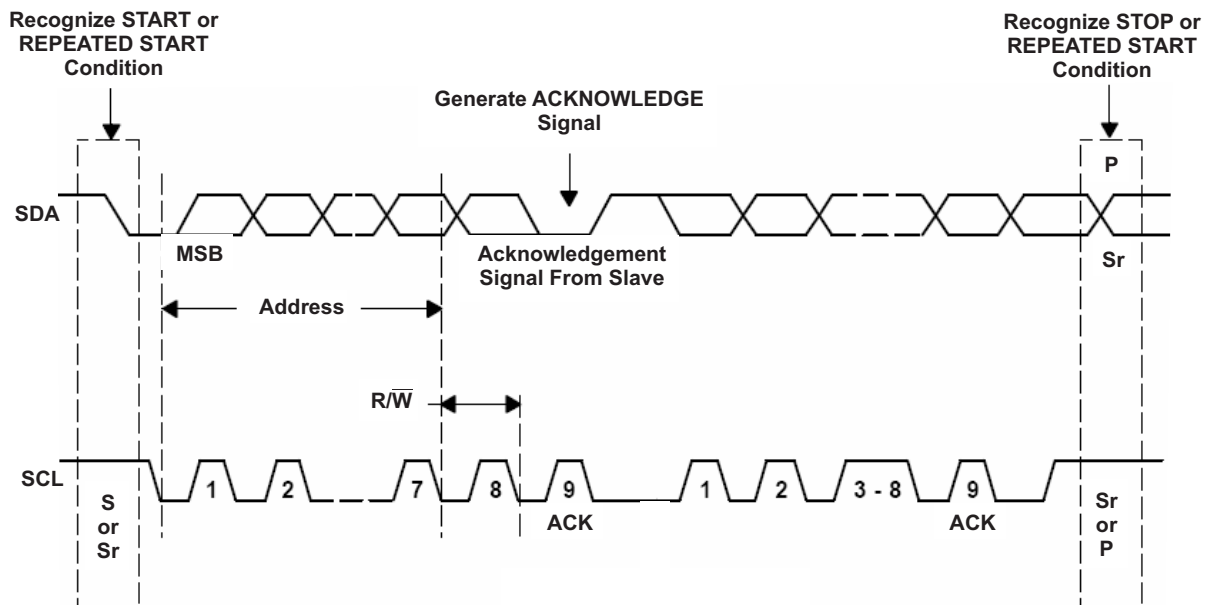
Figure 28. Bus Protocol

9.6 Register Maps

9.6.1 Register #1

Memory location: 00, Reset state: x0xx xxxx

BIT	NAME	READ/WRITE	FUNCTION
B7(MSB)	WD_FAULT	Read only	Read:0 – No fault 1 – WD timeout if WD enabled
B6	WD_EN	Read/Write	0 – Disable 1 – Enable (also resets WD timer)
B5	STAT_1	Read only	00 – Ready
B4	STAT_0	Read only	01 – Charge in progress 10 – Charge done 11 – Fault
B3	FAULT_3	Read only	0000 – Normal
B2	FAULT_2	Read only	0001 – Input OVP
B1	FAULT_1	Read only	0010 – Input UVLO 0011 – Sleep
B0(LSB)	FAULT_0	Read only	0100 – Battery Temperature (TS) Fault 0101 – Battery OVP 0110 – Thermal Shutdown 0111 – Timer Fault 1000 – No Battery connected 1001 – ISET short 1010 – Input Fault and LDO low

- **WD_FAULT –** '0' indicates no watch dog fault has occurred, where a '1' indicates a fault has previously occurred.
- **WD_EN –** Enables or disables the internal watch dog timer. A '1' enables the watch dog timer and a '0' disables it. '1' is default for bq24251 only.
- **STAT –** Indicates the charge controller status.
- **FAULT –** Indicates the faults that have occurred. If multiple faults occurred, they can be read by sequentially addressing this register (e.g. reading the register 2 or more times). Once all faults have been read and the device is in a non-fault state, the fault register will show "Normal". Regarding the "Input Fault & LDO Low" the IC indicates this if LDO is low and at the same time the input is below UVLO or coming out of UVLO with LDO still low.

9.6.2 Register #2

Memory location: 01, Reset state: xxxx 1100

BIT	NAME	READ/WRITE	FUNCTION
B7(MSB)	Reset	Write only	Write: 1 – Reset all registers to default values 0 – No effect
B6	$I_{IN\_ILIMIT\_2}$	Read/Write	000 – USB2.0 host with 100mA current limit
B5	$I_{IN\_ILIMIT\_1}$	Read/Write	001 – USB3.0 host with 150mA current limit
B4	$I_{IN\_ILIMIT\_0}$	Read/Write	010 – USB2.0 host with 500mA current limit 011 – USB3.0 host with 900mA current limit 100 – Charger with 1500mA current limit 101 – Charger with 2000mA current limit 110 – External ILIM current limit 111- No input current limit with internal clamp at 3A (PTM MODE)
B3	EN_STAT	Read/Write	0 – Disable STAT function 1 – Enable STAT function
B2	EN_TERM	Read/Write	0 – Disable charge termination 1 – Enable charge termination
B1	$\overline{CE}$	Read/Write	0 – Charging is enabled 1 – Charging is disabled
B0 (LSB)	HZ_MODE	Read/Write	0 – Not high impedance mode 1 – High impedance mode

- **I_{IN_LIMIT}** – Sets the input current limit level. When in host mode this register sets the regulation level. However, when in standalone mode (e.g. no I²C writes have occurred after power up or the WD timer has expired) the external resistor setting for I_{ILIM} sets the regulation level.
- **EN_STAT** – Enables and disables the STAT pin. When set to a '1' the STAT pin is enabled and function normally. When set to a '0' the STAT pin is disabled and the open drain FET is in HiZ mode.
- **EN_TERM** – Enables and disables the termination function in the charge controller. When set to a '1' the termination function will be enabled. When set to a '0' the termination function will be disabled. When termination is disabled, there are no indications of the charger terminating (i.e. STAT pin or STAT registers).
- **$\overline{CE}$** – The charge enable bit which enables or disables the charge function. When set to a '0', the charger operates normally. When set to a '1', the charger is disables by turning off the BAT FET between SYS and BAT. The SYS pin continues to stay active via the switch mode controller if an input is present.
- **HZ_MODE** – Sets the charger IC into low power standby mode. When set to a '1', the switch mode controller is disabled but the BAT FET remains ON to keep the system powered. When set to a '0', the charger operates normally.

9.6.3 Register #3

Memory location: 02, Reset state: 1000 1111

BIT	NAME	READ/WRITE	FUNCTION
B7(MSB)	VBATREG_5[1]	Read/Write	Battery Regulation Voltage: 640mV (default 1)
B6	VBATREG_4[1]	Read/Write	Battery Regulation Voltage: 320mV (default 0)
B5	VBATREG_3[1]	Read/Write	Battery Regulation Voltage: 160mV (default 0)
B4	VBATREG_2[1]	Read/Write	Battery Regulation Voltage: 80mV (default 0)
B3	VBATREG_1[1]	Read/Write	Battery Regulation Voltage: 40mV (default 1)
B2	VBATREG_0[1]	Read/Write	Battery Regulation Voltage: 20mV (default 1)
B1(4)(5)	USB_DET_1/EN2	Read Only	Return USB detection result or pin EN2/EN1 status –
B0(LSB)	USB_DET_0/EN1	Read Only	00 – DCP detected / EN2=0, EN1=0 01 – CDP detected / EN2=0, EN1=1 10 – SDP detected / EN2=1, EN1=0 11 – Apple/TT or non-standard adaptor detected / EN2=1, EN1=1

(1)   Charge voltage range is 3.5 V—4.44 V with the offset of 3.5 V and step of 20 mV (default 4.2 V)
- **V$_{BATREG}$** – Sets the battery regulation voltage
- **USB_DET/EN –** Provides status of the D+/D– detection-results for spins that include the D+/D– pins or the state of EN1/EN2 for spins that include the EN1/EN2 pins

9.6.4 Register #4

Memory location: 03, Reset state: 1111 1000

BIT	NAME	READ/WRITE	FUNCTION
B7(MSB)	ICHG_4[1] [2]	Read/Write	Charge current 800 mA – (default 1)
B6	ICHG_3[1] [2]	Read/Write	Charge current: 400 mA – (default 1)
B5	ICHG_2[1] [2]	Read/Write	Charge current: 200 mA – (default 1)
B4	ICHG_1[1] [2]	Read/Write	Charge current: 100 mA – (default 1)
B3	ICHG_0[1] [2]	Read/Write	Charge current: 50 mA – (default 1)
B2	ITERM_2[3]	Read/Write	Termination current sense threshold: 100 mA (default 0)
B1	ITERM_1[3]	Read/Write	Termination current sense threshold: 50 mA (default 0)
B0(LSB)	ITERM_0[3]	Read/Write	Termination current sense threshold: 25 mA (default 0)

(1)   Charge current offset is 500 mA and default charge current is external (maximum is 2.0A)
(2)   When all bits are 1's, it is external ISET charging mode
(3)   Termination threshold voltage offset is 50 mA. The default termination current is 50 mA if the charge is selected from I^{2}C. Otherwise, termination is set to 10% of ICHG in external I_set mode with ±10% accuracy.
- **I$_{CHG}$** – Sets the charge current regulation
- **I$_{TERM}$** – Sets the current level at which the charger will terminate

9.6.5 Register #5

Memory location: 04, Reset state: xx00 x010

BIT	NAME	READ/WRITE	FUNCTION
B7(MSB)	LOOP_STATUS1[1]	Read Only	00 – No loop is active that slows down timer
B6	LOOP_STATUS0[1]	Read Only	01 – V_{IN_DPM} regulation loop is active 10 – Input current limit loop is active 11 – Thermal regulation loop is active
B5	LOW_CHG	Read/Write	0 – Normal charge current set by 03h 1 – Low charge current setting 330mA (default 0)
B4	DPDM_EN	Read/Write	0 – Bit returns to 0 after D+/D− detection is performed 1 – Force D+/D− detection (default 0)
B3	CE_STATUS	Read Only	0 – CE low 1 – CE high
B2	V_{INDPM_2} [2]	Read/Write	Input V_{IN-DPM} voltage: 320mV (default 0)
B1	V_{INDPM_1} [2]	Read/Write	Input V_{IN-DPM} voltage: 160mV (default 1)
B0(LSB)	V_{INDPM_0} [2]	Read/Write	Input V_{IN-DPM} voltage: 80mV (default 0)

(1) LOOP_STATUS bits show if there are any loop is active that slow down the safety timer. If a status occurs, these bits announce the status and do not clear until read. If more than one occurs, the first one is shown.
(2) VIN-DPM voltage offset is 4.20V and default V_{IN_DPM} threshold is 4.36 V.

- **LOOP_STATUS –** Provides the status of the active regulation loop. The charge controller allows for only one loop can regulate at a time.
- **LOW_CHG –** When set to a '1', the charge current is reduced 330mA independent of the charge current setting in register 0x03. When set to '0', the charge current is set by register 0x03.
- **DPDM_EN –** Forces a D+/D- detection routine to be executed once a '1' is written. This is independent of the input being supplied.
- **CE_STATUS –** Provides the status of the $\overline{CE}$ pin level. If the $\overline{CE}$ pin is forced high, this bit returns a '1'. If the $\overline{CE}$ pin is forced low, this bit returns a '0'.
- **V_{INDPM} –** Sets the input VDPM level.

9.6.6 Register #6

Memory location: 05, Reset state: 101x 1xxx

BIT	NAME	READ/WRITE	FUNCTION
B7(MSB)	2XTMR_EN	Read/Write	0 – Timer not slowed at any time 1 – Timer slowed by 2x when in thermal regulation, V_{IN_DPM} or DPPM (default 1)
B6	TMR_1	Read/Write	Safety Timer Time Limit
B5	TMR_2	Read/Write	00 – 0.75 hour fast charge 01 – 6 hour fast charge (default 01) 10 – 9 hour fast charge 11 – Disable safety timers
B4	SYSOFF	Read/Write	0 – SYSOFF disabled 1 – SYSOFF enabled
B3	TS_EN	Read/Write	0 – TS function disabled 1 – TS function enabled (default 1)
B2	TS_STAT2	Read only	TS Fault Mode:
B1	TS_STAT1	Read only	000 – Normal, No TS fault 001 – TS temp > T_{HOT} (Charging suspended for JEITA and Standard TS)
B0(LSB)	TS_STAT0	Read only	010 – T_{WARM} < TS temp < T_{HOT} (Regulation voltage is reduced for JEITA standard) 011 – T_{COLD} < TS temp < T_{COOL} (Charge current is reduced for JEITA standard) 100 – TS temp < T_{COLD} (Charging suspended for JEITA and Standard TS) 101 – T_{FREEZE} < TS temp < T_{COLD} (Charging at 3.9V and 100mA and only for PSE option only) 110 – TS temp < T_{FREEZE} (Charging suspended for PSE option only) 111 – TS open (TS disabled)

- **2xTMR_EN –** When set to a '1', the 2x Timer function is enabled and allows for the timer to be extended if a condition occurs where the charge current is reduced (i.e. V_{IN_DPM}, thermal regulation, etc.). When set to a '0', this function is disabled and the normal timer will always be executed independent of the current reduce conditions.
- **SYSOFF –** When set to a '1' and the input is removed, the internal battery FET is turned off in order to reduce the leakage from the BAT pin to less than 1μA. Note that this disconnects the battery from the system. When set to a '0', this function is disabled.
- **TS_EN –** Enables and disables the TS function. When set to a '0' the TS function is disabled otherwise it is enabled. Only applies to spins that have a TS pin.
- **TS_STAT –** Provides status of the TS pin state for versions that have a TS pin. "100" indicates the TS temp < T_{COLD} and charging suspended for JEITA Standard. In order to ensure continuation of the charge process when an almost-full battery stops charging due to a cold temperature fault, it is recommended that a CE toggle is done on the I2C or CE pin.

9.6.7 Register #7

Memory location: 06, Reset state: 1110 0000

BIT	NAME	READ/WRITE	FUNCTION
B7(MSB)	VOVP_2	Read/Write	OVP voltage:
B6	VOVP_1	Read/Write	000 – 6.0 V; 001 – 6.5 V; 010 – 7.0 V; 011 – 8.0 V
B5	VOVP_0	Read/Write	100 – 9.0 V; 101 – 9.5 V; 110 – 10.0 V; 111 –10.5 V
B4	CLR_VDP	Read/Write	0 – Keep D+ voltage source on during DBP charging 1 – Turn off D+ voltage source to release D+ line
B3	FORCE_BAT DET	Read/Write	0 – Enter the battery detection routine only if TERM is true or Force PTM is true 1 – Enter the battery detection routine
B2	FORCE_PTM	Read/Write	0 – PTM mode is disabled 1 – PTM mode is enabled
B1	N/A	Read/Write	Not available. Keep set to 0.
B0(LSB)	N/A	Read/Write	Not available. Keep set to 0.

- **VOVP –** Sets the OVP level
- **CLR_VDP –** When the D+/D− detection has finished, some cases require the D+ pin to force a voltage of 0.6 V. This bit allows the system to clear the voltage prior to any communication on the D+/D− pins. A '1' clears the voltage at the D+ pin if present.
- **FORCE_BATDET –** Forces battery detection and provides status of the battery presence. A logic '1' enables this function.
- **FORCE_PTM –** Puts the device in production test mode (PTM) where the input current limit is disabled. Note that a battery must not be present prior to using this function. Otherwise the function will not be allowed to execute. A logic '1' enables the PTM function.

10 Application and Implementation

> **NOTE**
>
> Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

The bq2425x devices are high-efficiency switched-mode chargers. The device has integrated power FETs that are able to charge at up to a 2-A charging rate, and an integrated 50-mA LDO. In I2C mode (bq24251), the device has programmable battery charge voltage (VBATREG), charge current (ICHG), input current limit (ILIM), and input over-voltage protection threshold (VOVP). The charge current and the input current limit are programmed using external resistors (RISET and RILIM) connected from the ISET and ILIM pins to ground. The range of these resistors can be found in the datasheet. Both of these currents can be programmed up to 2 A. The device also has complete system-level protection such as input under-voltage lockout (UVLO), input over-voltage protection (OVP), battery OVP, sleep mode, thermal regulation and thermal shutdown, voltage-based NTC monitoring input, and safety timers.

10.2 Typical Application
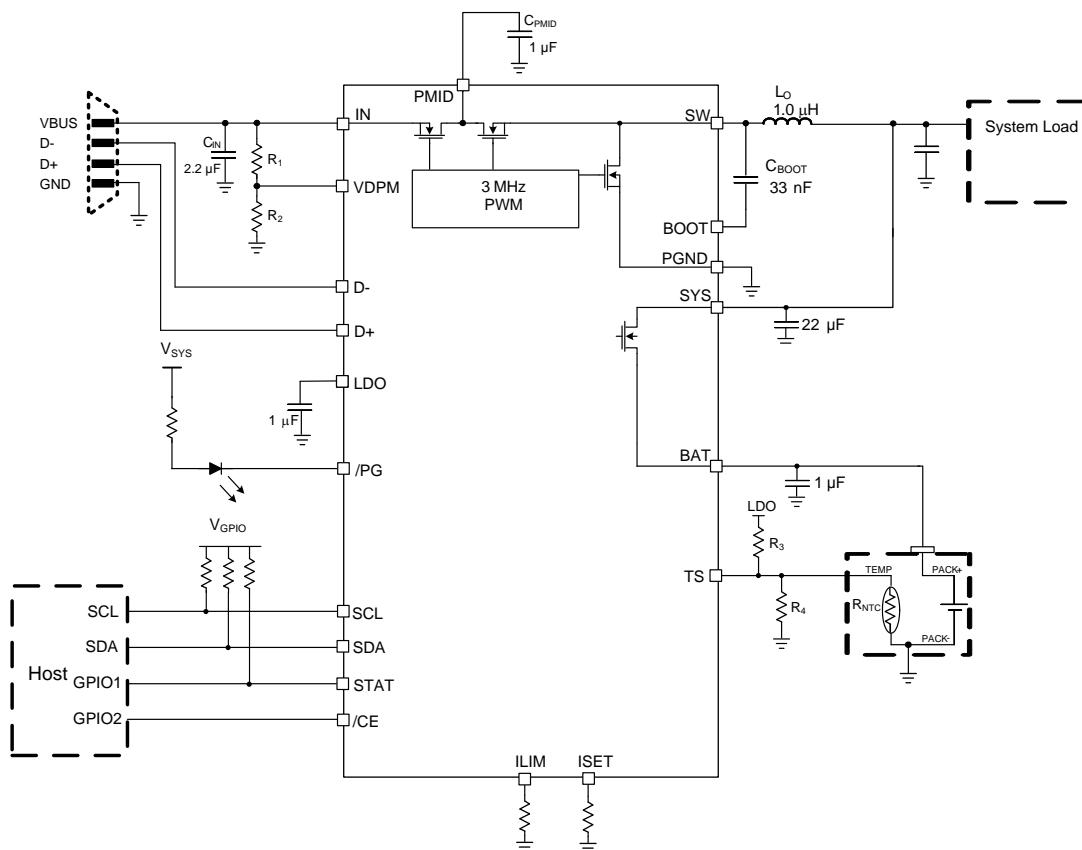
Figure 29. bq24251 Typical Application Circuit

Typical Application (continued)

10.2.1 Design Requirements

Use the following typical application design procedure to select external components values for the bq24251 device.

Table 5. Design Parameters

SPECIFICATION	TEST CONDITION	MIN	TYP	MAX	UNIT
Input DC voltage, VIN	Recommended input voltage range	4.35		10.5	V
Input current	Recommended input current range			2	A
Charge current	Fast charge current range	0.5		2	A
Output regulation voltage	Standalone mode or I2C default mode		4.2		V
Output regulation voltage	I2C host mode: operating in voltage regulation, programmable range	3.5		4.44	V
LDO	LDO output voltage		4.9		V

10.2.2 Detailed Design Procedure

10.2.2.1 Inductor Selection

The inductor selection depends on the application requirements. The bq24250 is designed to operate at around 1 µH. The value will have an effect on efficiency, and the ripple requirements, stability of the charger, package size, and DCR of the inductor. The 1-µH inductor provides a good tradeoff between size and efficiency and ripple.

Once the inductance has been selected, the peak current is needed in order to choose the saturation current rating of the inductor. Make sure that the saturation current is always greater than or equal to the calculated IPEAK. The following equation can be used to calculate the current ripple:

$$\Delta I_L = \{VBAT (VIN - VBAT)\}/(VIN \times \mathit{f}s \times L) \tag{6}$$

Then use current ripple to calculate the peak current as follows:

$$I_{PEAK} = Load \times (1 + \Delta I_L/2) \tag{7}$$

In this design example, the regulation voltage is set to 4.2 V, the input voltage is 5 V and the inductance is selected to be 1-µH. The maximum charge current that can be used in this application is 1A and can be set by I2C command. The peak current is needed in order to choose the saturation current rating of the inductor. Using equation 6 and 7, ΔI_L is calculated to be 0.224 A and the inductor peak current is 1.112 A. A 1-µF BAT cap is needed and 22-µF SYS cap is needed on the system trace.

The default settings for external fast charge current and external setting of current limit are chosen to be IFC=500 mA and ILIM=1 A. RISET and RILIM need to be calculated using equation 1 and 2 in the data sheet.

The fast charge current resistor (RISET) can be set as follows:

RISET=250/0.5A=500Ω

The input current limit resistor (RILIM) can be set as follows:

RILIM= 270/1A=270Ω

The external settings of VIN_DPM can be designed by calculating R1 and R2 according to Equation 3 in this data sheet and the typical application circuit. VIN_DPM should be chosen first along with R1. VIN_DPM is chosen to be 4.48 V and R1 is set to 274 KΩ in this design example. Using equation 3, the value of R2 is calculated to be 100 KΩ.

In this design example, the application needs to be JEITA compliant. Thus, T_{COLD} must be 0°C and T_{HOT} must be 60°C. If an NTC resistor is chosen such that the beta is 4500K and the nominal resistance is 13 KΩ, the calculated R3 and R4 values are 5 KΩ and 8.8 KΩ respectively. These results are obtained from Equation 4 and Equation 5 in this data sheet.

10.2.3 Application Curves

V_{BAT} = 3.8 V I_{CHG} = 1 A
I_{SYS} = 0 A I_{LIM} = 1.5 A

Figure 30. Startup

V_{BAT} = 3.6 V I_{CHG} = 2 A V_{DPM} = 4.36 V
I_{SYS} = 0 A I_{LIM} = 0.5 A

Figure 31. V_{DPM} Startup, 4.2 V

V_{BAT} = 3.3 V I_{CHG} = 1 A V_{IN} = 5.2 V
I_{SYS} = 0 A

Figure 32. 1.0 µH CCM Operation

Figure 33. 2-A Load Step Transient
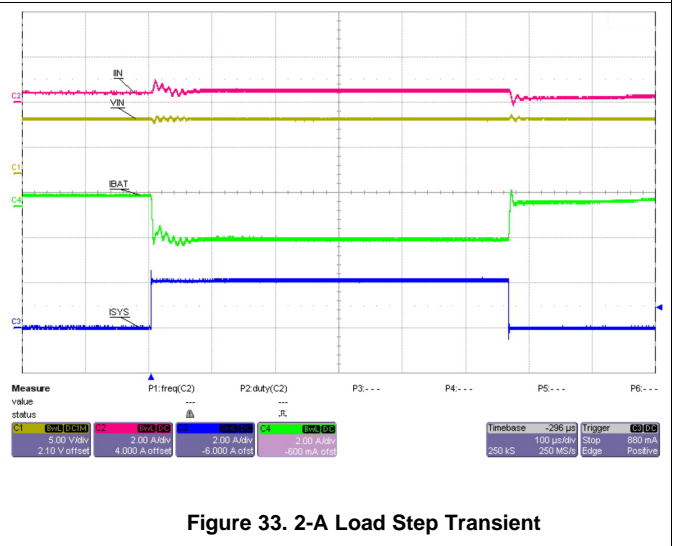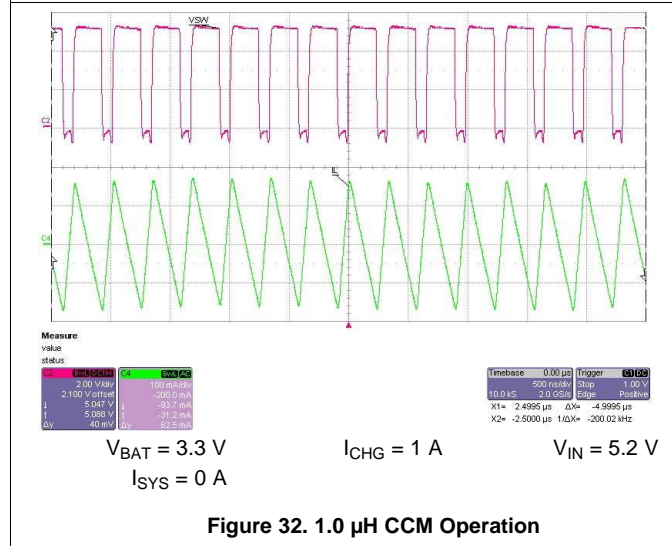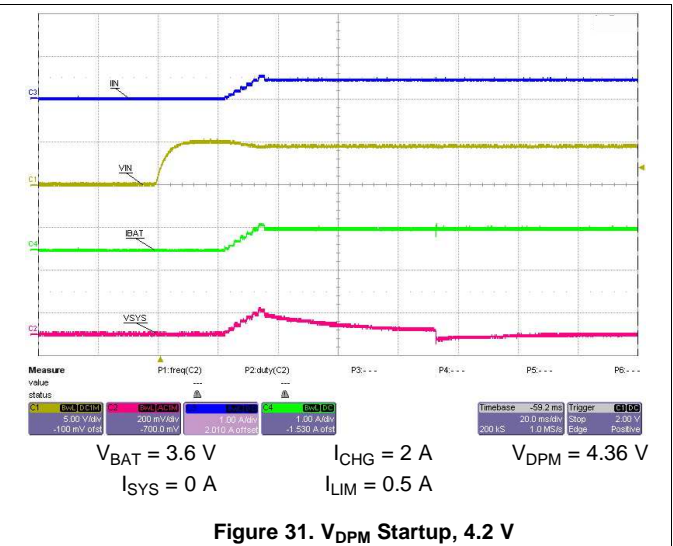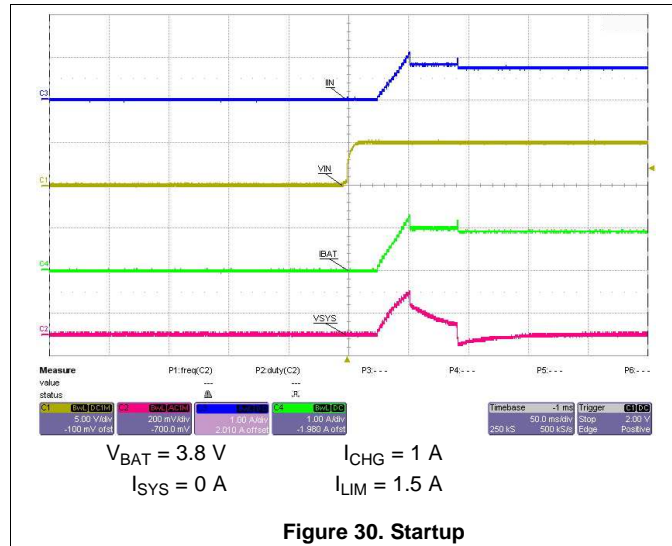
11 Power Supply Recommendations

The devices are designed to operate from an input voltage range between 4.35V and 10.5V. This input supply must be well regulated. If the input supply is located more than a few inches from the bq24250 charger, additional bulk capacitance may be required in addition to the ceramic bypass capacitors.

12 Layout

12.1 Layout Guidelines

1. Place the BOOT, PMID, IN, BAT, and LDO capacitors as close as possible to the IC for optimal performance.
2. Connect the inductor as close as possible to the SW pin, and the SYS/CSIN cap as close as possible to the inductor minimizing noise in the path.
3. Place a 1-μF PMID capacitor as close as possible to the PMID and PGND pins, making the high frequency current loop area as small as possible.
4. The local bypass capacitor from SYS/CSIN to GND must be connected between the SYS/CSIN pin and PGND of the IC. This minimizes the current path loop area from the SW pin through the LC filter and back to the PGND pin.
5. Place all decoupling capacitors close to their respective IC pins and as close as possible to PGND (do not place components such that routing interrupts power-stage currents). All small control signals must be routed away from the high-current paths.
6. To reduce noise coupling, use a ground plane if possible, to isolate the noisy traces from spreading its noise all over the board. Put vias inside the PGND pads for the IC.
7. The high-current charge paths into IN, Micro-USB, BAT, SYS/CSIN, and from the SW pins must be sized appropriately for the maximum charge current to avoid voltage drops in these traces.
8. For high-current applications, the balls for the power paths must be connected to as much copper in the board as possible. This allows better thermal performance because the board conducts heat away from the IC.

12.2 Layout Example
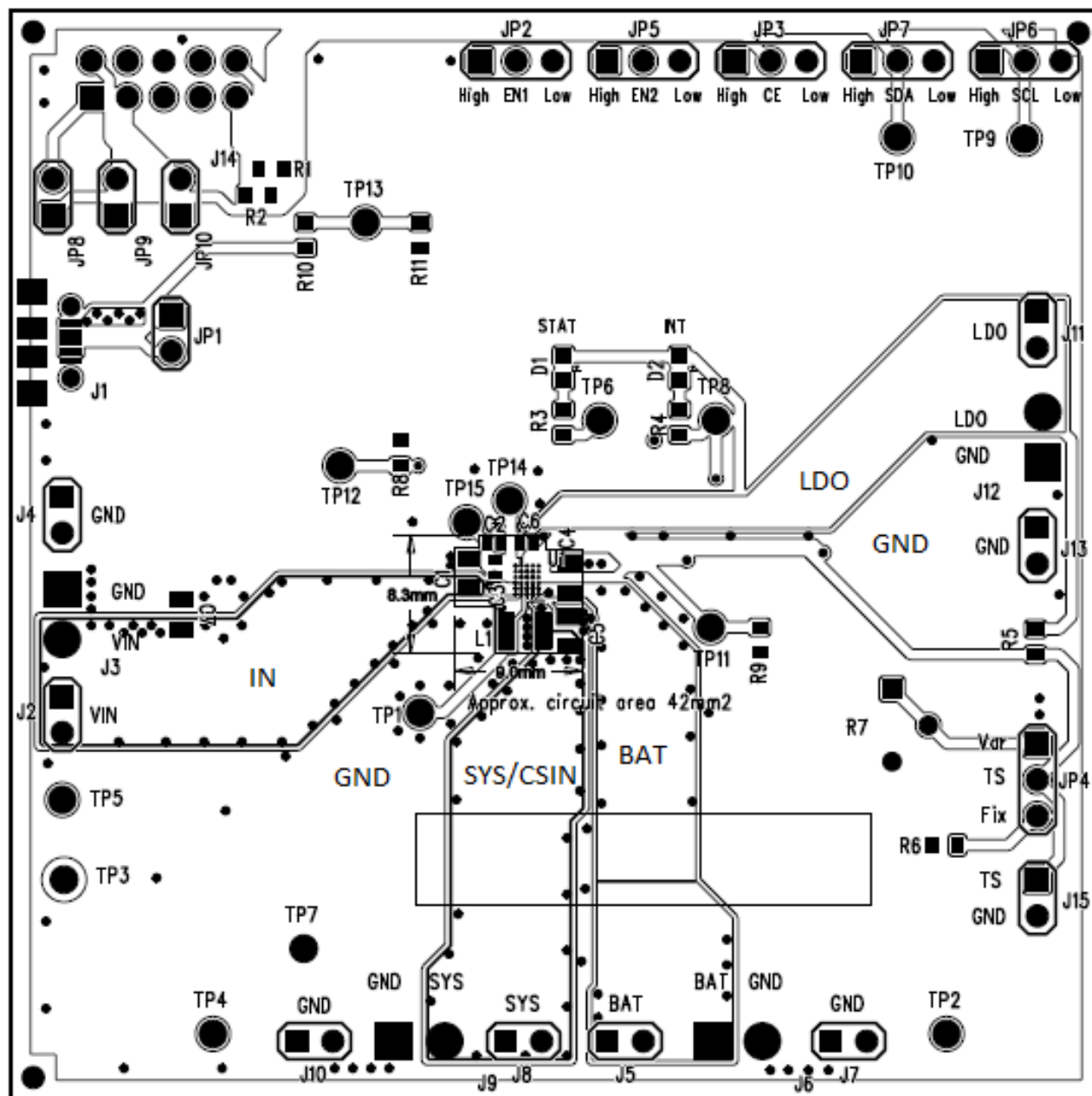
Figure 34. Recommended bq2425x PCB Layout for DSBGA Package

12.3 Thermal Considerations

During the charging process, to prevent overheat of the chip, bq2425x monitors the junction temperature, T_J, of the die and begins to taper down the charge current once T_J reaches the thermal regulation threshold, TREG. The charge current is reduced when the junction temperature increases above TREG. Once the charge current is reduced, the system current is reduced while the battery supplements the load to supply the system. This may cause a thermal shutdown of the IC if the die temperature rises too. At any state, if T_J exceeds TSHTDWN, bq2425x suspends charging and disables the buck converter. During thermal shutdown mode, PWM is turned off, all safety timers are suspended, and a single $256\mu s$ pulse is sent on the STAT and INT outputs and the FAULT/STAT bits of the status registers are updated in the I2C. A new charging cycle begins when T_J falls below TSHTDWN by approximately 10°C.

13 器件和文档支持

13.1 相关链接

下面的表格列出了快速访问链接。类别包括技术文档、支持与社区资源、工具和软件，以及申请样片或购买产品的快速链接。

表 **6.** 相关链接

器件	产品文件夹	样片与购买	技术文档	工具和软件	支持和社区
bq24251	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
bq24253	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处

13.2 商标

All trademarks are the property of their respective owners.

13.3 静电放电警告

这些装置包含有限的内置 ESD 保护。 存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

13.4 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

14 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。这些数据如有变更，恕不另行通知和修订此文档。如欲获取此数据表的浏览器版本，请参阅左侧的导航。

14.1 封装摘要

**YFF Package
(Top View)**

**YFF Package Symbol
(Top Side Symbol for bq2425x)**

TI YMLLLLS
bq24251

TI YMLLLLS
bq24253
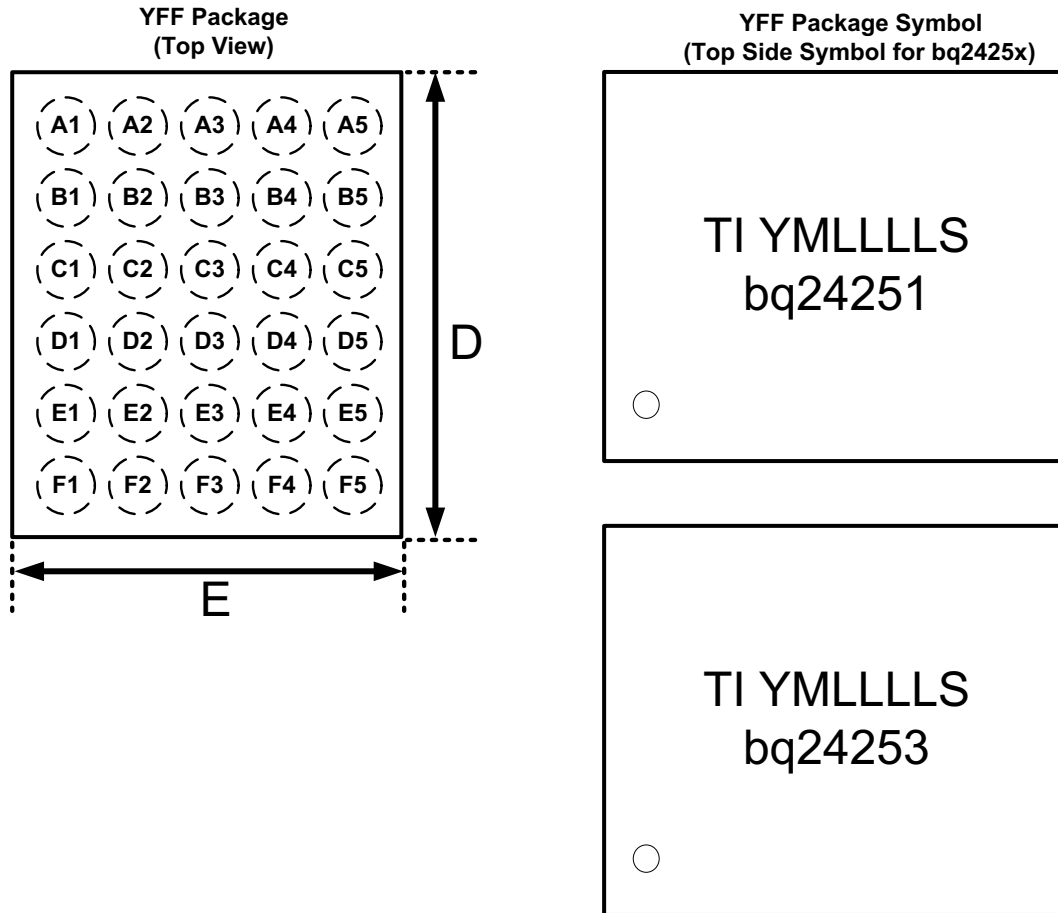
**0-Pin A1 Marker, TI-TI Letters, YM- Year Month Date Code,
LLLL-Lot Trace Code, S-Assembly Site Code**

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
BQ24250RGER	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	BQ24250
BQ24250RGER.A	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24250
BQ24250RGERG4	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24250
BQ24250RGERG4.A	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24250
BQ24250RGET	Active	Production	VQFN (RGE) | 24	250 | SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-	BQ24250
BQ24250RGET.A	Active	Production	VQFN (RGE) | 24	250 | SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24250
BQ24250YFFR	Active	Production	DSBGA (YFF) | 30	3000 | LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24250
BQ24250YFFR.A	Active	Production	DSBGA (YFF) | 30	3000 | LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24250
BQ24250YFFT	Active	Production	DSBGA (YFF) | 30	250 | SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24250
BQ24250YFFT.A	Active	Production	DSBGA (YFF) | 30	250 | SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24250
BQ24251RGER	NRND	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24251
BQ24251RGER.A	NRND	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24251
BQ24251RGET	NRND	Production	VQFN (RGE) | 24	250 | SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24251
BQ24251RGET.A	NRND	Production	VQFN (RGE) | 24	250 | SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24251
BQ24251YFFR	NRND	Production	DSBGA (YFF) | 30	3000 | LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24251
BQ24251YFFR.A	NRND	Production	DSBGA (YFF) | 30	3000 | LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24251
BQ24251YFFT	NRND	Production	DSBGA (YFF) | 30	250 | SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24251
BQ24251YFFT.A	NRND	Production	DSBGA (YFF) | 30	250 | SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24251
BQ24253RGER	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24253
BQ24253RGER.A	Active	Production	VQFN (RGE) | 24	3000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24253
BQ24253RGET	Active	Production	VQFN (RGE) | 24	250 | SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24253
BQ24253RGET.A	Active	Production	VQFN (RGE) | 24	250 | SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	BQ24253
BQ24253YFFR	Active	Production	DSBGA (YFF) | 30	3000 | LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24253
BQ24253YFFR.A	Active	Production	DSBGA (YFF) | 30	3000 | LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24253
BQ24253YFFT	Active	Production	DSBGA (YFF) | 30	250 | SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24253
BQ24253YFFT.A	Active	Production	DSBGA (YFF) | 30	250 | SMALL T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ24253

(1) Status: For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ24250RGER	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
BQ24250RGERG4	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
BQ24250RGET	VQFN	RGE	24	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
BQ24250YFFR	DSBGA	YFF	30	3000	180.0	8.4	2.09	2.59	0.78	4.0	8.0	Q1
BQ24250YFFT	DSBGA	YFF	30	250	180.0	8.4	2.09	2.59	0.78	4.0	8.0	Q1
BQ24251RGER	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
BQ24251RGET	VQFN	RGE	24	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
BQ24251YFFR	DSBGA	YFF	30	3000	180.0	8.4	2.09	2.59	0.78	4.0	8.0	Q1
BQ24251YFFT	DSBGA	YFF	30	250	180.0	8.4	2.09	2.59	0.78	4.0	8.0	Q1
BQ24253RGER	VQFN	RGE	24	3000	330.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
BQ24253RGET	VQFN	RGE	24	250	180.0	12.4	4.25	4.25	1.15	8.0	12.0	Q2
BQ24253YFFR	DSBGA	YFF	30	3000	180.0	8.4	2.09	2.59	0.78	4.0	8.0	Q1
BQ24253YFFT	DSBGA	YFF	30	250	180.0	8.4	2.09	2.59	0.78	4.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ24250RGER	VQFN	RGE	24	3000	346.0	346.0	33.0
BQ24250RGERG4	VQFN	RGE	24	3000	346.0	346.0	33.0
BQ24250RGET	VQFN	RGE	24	250	182.0	182.0	20.0
BQ24250YFFR	DSBGA	YFF	30	3000	182.0	182.0	20.0
BQ24250YFFT	DSBGA	YFF	30	250	182.0	182.0	20.0
BQ24251RGER	VQFN	RGE	24	3000	346.0	346.0	33.0
BQ24251RGET	VQFN	RGE	24	250	182.0	182.0	20.0
BQ24251YFFR	DSBGA	YFF	30	3000	182.0	182.0	20.0
BQ24251YFFT	DSBGA	YFF	30	250	182.0	182.0	20.0
BQ24253RGER	VQFN	RGE	24	3000	346.0	346.0	33.0
BQ24253RGET	VQFN	RGE	24	250	182.0	182.0	20.0
BQ24253YFFR	DSBGA	YFF	30	3000	182.0	182.0	20.0
BQ24253YFFT	DSBGA	YFF	30	250	182.0	182.0	20.0

B — E — A

BUMP A1
CORNER

D

0.625 MAX

0.30
0.12

BALL TYP

C

SEATING PLANE

⌓ 0.05 C

1.6 TYP

SYMM
₵

F
E
D
C
B
A

1 2 3 4 5

2
TYP

SYMM
₵

D: Max = 2.418 mm, Min =2.357 mm

E: Max = 2.018 mm, Min =1.957 mm

0.4 TYP

30X ⌀ 0.3
       0.2

0.4 TYP

⊕ 0.015Ⓜ C A B

4219433/A   03/2016

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing
   per ASME Y14.5M.
2. This drawing is subject to change without notice.

YFF0030

DIE SIZE BALL GRID ARRAY
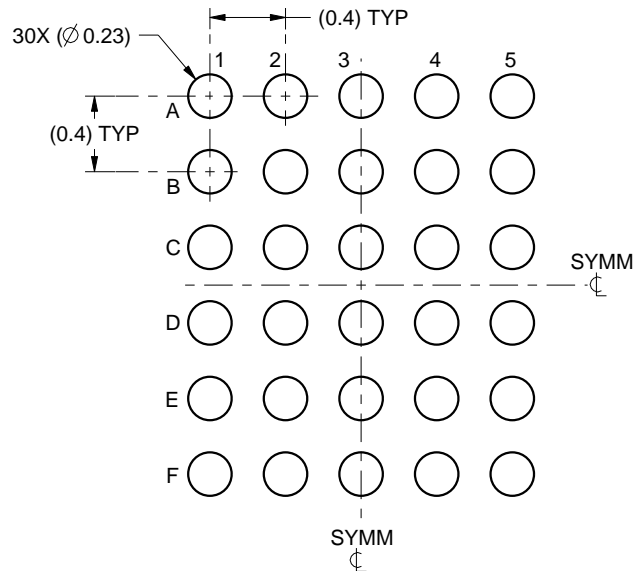
LAND PATTERN EXAMPLE
SCALE:25X

SOLDER MASK DETAILS
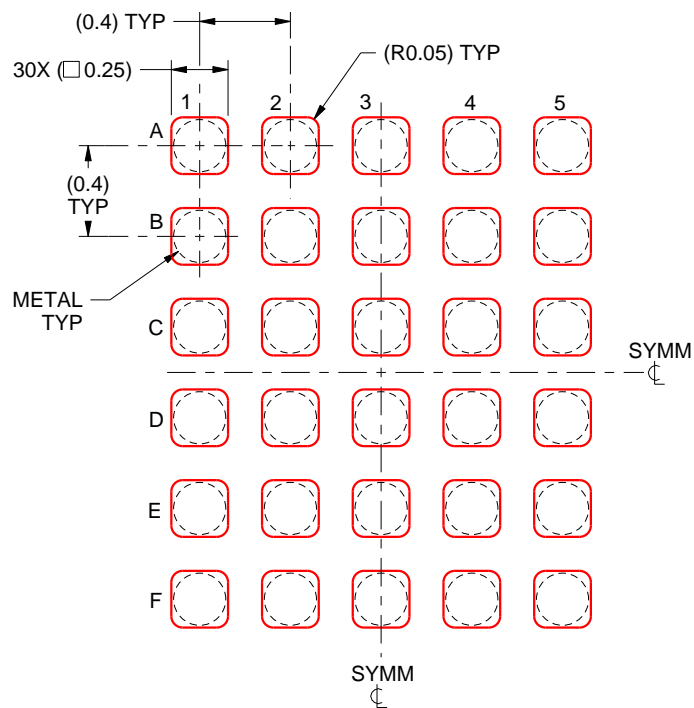NOT TO SCALE
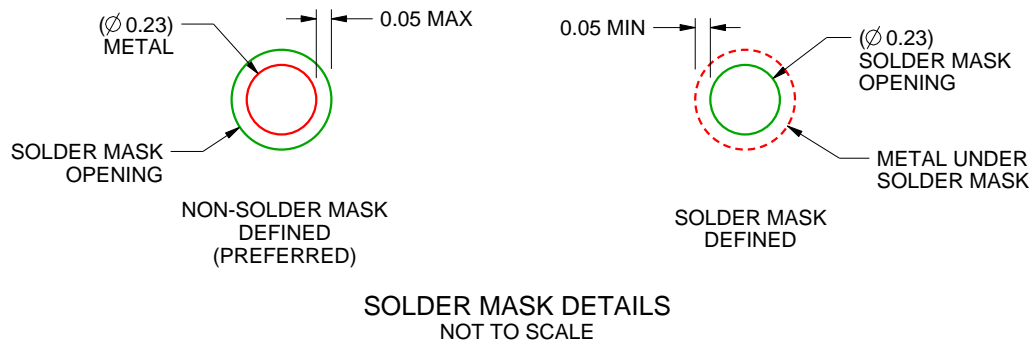
4219433/A   03/2016

NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints.
   For more information, see Texas Instruments literature number SNVA009 (www.ti.com/lit/snva009).

(0.4) TYP

30X (□0.25)

(R0.05) TYP

(0.4) TYP

METAL TYP

SYMM ℄

SYMM ℄

SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICK STENCIL
SCALE:30X

4219433/A   03/2016

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.
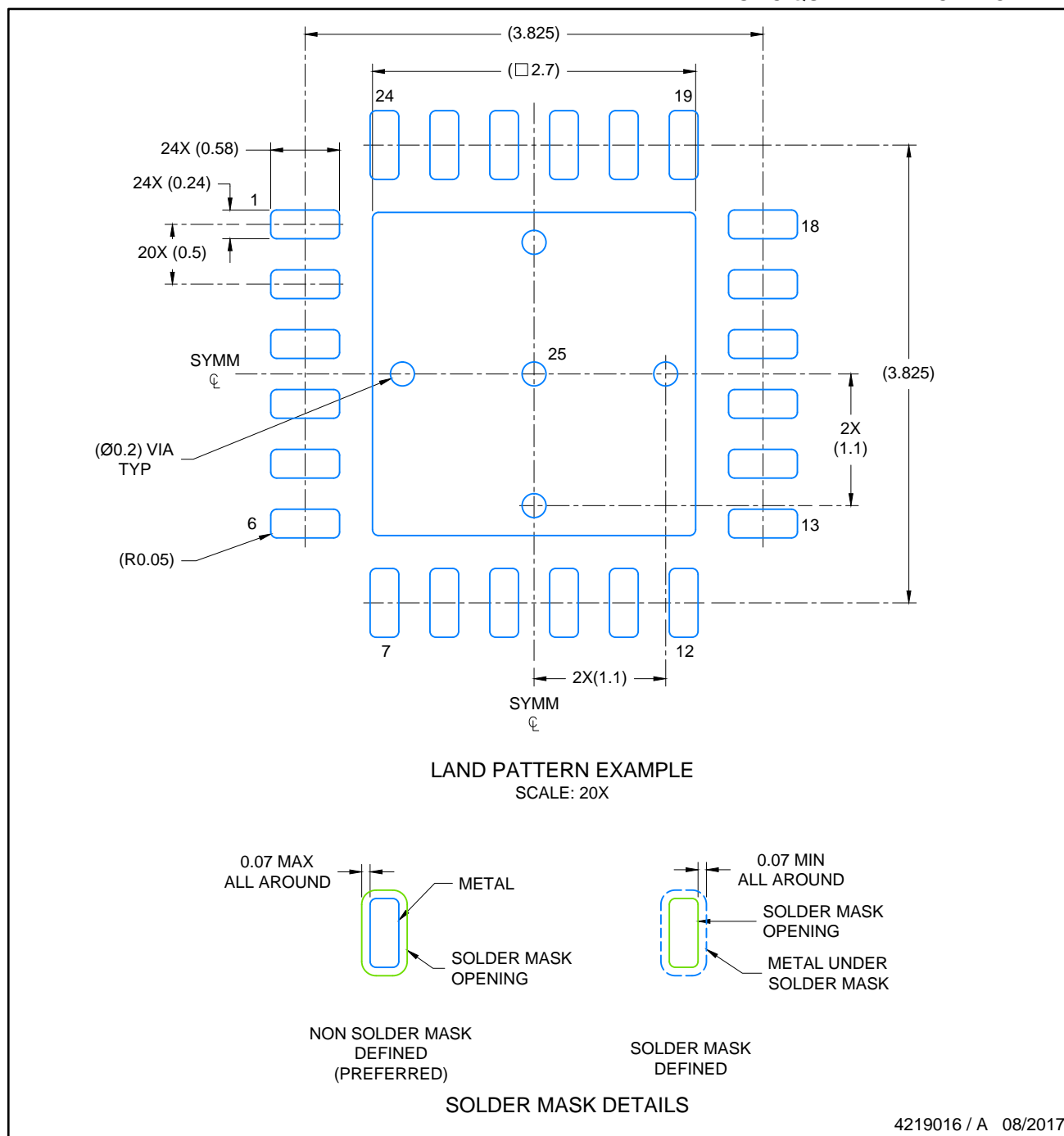
Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4204104/H

TEXAS
INSTRUMENTS

PLASTIC QUAD FLATPACK- NO LEAD

B

4.1
3.9

A

PIN 1 INDEX AREA

4.1
3.9

1 MAX

0.05
0.00

C

SEATING PLANE

0.08 | C

□ 2.7±0.1

2X 2.5

(0.2) TYP

7   12

20X 0.5

6

13

2X
2.5

25

SYMM
℄

1

PIN 1 ID
(OPTIONAL)

18

24X 0.30
0.18

24   19

24X 0.48
0.28

0.1 (M) | C | A | B
0.05 (M) | C

SYMM
℄

4219016 / A   08/2017

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

LAND PATTERN EXAMPLE
SCALE: 20X

(3.825)

(□ 2.7)

24   19

24X (0.58)

24X (0.24)

1

20X (0.5)

SYMM
℄

(Ø0.2) VIA
TYP

6

(R0.05)

18

25

(3.825)

2X
(1.1)

13

7   12

2X(1.1)

SYMM
℄

0.07 MAX
ALL AROUND

METAL

SOLDER MASK
OPENING

NON SOLDER MASK
DEFINED
(PREFERRED)

0.07 MIN
ALL AROUND

SOLDER MASK
OPENING

METAL UNDER
SOLDER MASK

SOLDER MASK
DEFINED

SOLDER MASK DETAILS

4219016 / A   08/2017

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments
    literature number SLUA271 (www.ti.com/lit/slua271).
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

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INSTRUMENTS

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SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
78% PRINTED COVERAGE BY AREA
SCALE: 20X

4219016 / A   08/2017

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations..

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